

TEST REPORT

Reference No...... : WTD15S0122525E
FCC ID : 2AA3H-HXP750
Applicant..... : Shenzhen 3nod Digital Technology Co., Ltd.
Address..... : Building D Park 8# Langhui Road Tangxiayong Village, Industrial Zone
Songgang Town, Baoan District, Shenzhen City, China.
Manufacturer : The same as above
Address..... : The same as above
Product Name..... : Jam Platinum
Model No : HX-P750
Standards..... : FCC CFR47 Part 15 Section 15.247:2013
Date of Receipt sample : Jan, 26, 2015
Date of Test : Jan, 26, 2015 ~ Jan. 28, 2015
Date of Issue..... : Jan. 30, 2015
Test Result..... : **Pass**

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

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Approved by:



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2 Test Summary

Test Items	Test Requirement	Result
Radiated Spurious Emissions	15.205(a) 15.209 15.247(d)	PASS
Band edge	15.247(d) 15.205(a)	PASS
Conduct Emission	15.207	PASS
20dB Bandwidth	15.247(a)(1)	PASS
Maximum Peak Output Power	15.247(b)(1)	PASS
Frequency Separation	15.247(a)(1)	PASS
Number of Hopping Frequency	15.247(a)(1)(iii)	PASS
Dwell time	15.247(a)(1)(iii)	PASS
Maximum Permissible Exposure (Exposure of Humans to RF Fields)	1.1307(b)(1)	PASS

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4 General Information

4.1 General Description of E.U.T.

Product Name:	Jam Platinum
Model No.:	HX-P750
Operation Frequency:	2402MHz ~ 2480MHz, 79 channels in total
Type of Modulation:	GFSK, Pi/4DQPSK, 8DPSK
The lowest oscillator:	16 MHz
Antenna installation:	PCB printed antenna
Antenna Gain:	0dBi

4.2 Details of E.U.T.

Technical Data:	DC 3.7V 1000mAh battery
	DC 5V for charging

4.3 Channel List

Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
0	2402	1	2403	2	2404	3	2405
4	2406	5	2407	6	2408	7	2409
8	2410	9	2411	10	2412	11	2413
12	2414	13	2415	14	2416	15	2417
16	2418	17	2419	18	2420	19	2421
20	2422	21	2423	22	2424	23	2425
24	2426	25	2427	26	2428	27	2429
28	2430	29	2431	30	2432	31	2433
32	2434	33	2435	34	2436	35	2437
36	2438	37	2439	38	2440	39	2441
40	2442	41	2443	42	2444	43	2445
44	2446	45	2447	46	2448	47	2449
48	2450	49	2451	50	2452	51	2453
52	2454	53	2455	54	2456	55	2457
56	2458	57	2459	58	2460	59	2461
60	2462	61	2463	62	2464	63	2465
64	2466	65	2467	66	2468	67	2469
68	2470	69	2471	70	2472	71	2473
72	2474	73	2475	74	2476	75	2477
76	2478	77	2479	78	2480	-	-

4.4 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting	2402MHz	2441MHz	2480MHz

4.5 Test Facility

The test facility has a test site registered with the following organizations:

- **IC – Registration No.: 7760A-1**

Waltek Services(Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files. Registration 7760A-1, July 12, 2012.

- **FCC Test Site 1#– Registration No.: 880581**

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory `has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581, April 29, 2014.

- **FCC Test Site 2#– Registration No.: 328995**

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory `has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 328995, December 3, 2014.

5 Equipment Used during Test

5.1 Equipments List

Conducted Emissions Test Site 1#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1.	EMI Test Receiver	R&S	ESCI	100947	Sep.15,2014	Sep.14,2015
2.	LISN	R&S	ENV216	101215	Sep.15,2014	Sep.14,2015
3.	Cable	Top	TYPE16(3.5M)	-	Sep.15,2014	Sep.14,2015
Conducted Emissions Test Site 2#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1.	EMI Test Receiver	R&S	ESCI	101155	Sep.15,2014	Sep.14,2015
2.	LISN	SCHWARZBECK	NSLK 8128	8128-289	Sep.15,2014	Sep.14,2015
3.	Limiter	York	MTS-IMP-136	261115-001-0024	Sep.15,2014	Sep.14,2015
4.	Cable	LARGE	RF300	-	Sep.15,2014	Sep.14,2015
3m Semi-anechoic Chamber for Radiation Emissions Test site 1#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1	EMC Analyzer	Agilent	E7405A	MY45114943	Sep.15,2014	Sep.14,2015
2	Active Loop Antenna	Beijing Dazhi	ZN30900A	-	Sep.15,2014	Sep.14,2015
3	Trilog Broadband Antenna	SCHWARZBECK	VULB9163	336	Apr.19,2014	Apr.18,2015
4	Coaxial Cable (below 1GHz)	Top	TYPE16(13M)	-	Sep.15,2014	Sep.14,2015
5	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9120 D	667	Apr.19,2014	Apr.18,2015
6	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9170	335	Apr.19,2014	Apr.18,2015
7	Broadband Preamplifier	COMPLIANCE DIRECTION	PAP-1G18	2004	Mar.17,2014	Mar.16,2015
8	Coaxial Cable (above 1GHz)	Top	1GHz-25GHz	EW02014-7	Apr.10,2014	Apr.09,2015
3m Semi-anechoic Chamber for Radiation Emissions Test site 2#						
Item	Equipment	Manufacturer	Model No.	Serial No	Last Calibration Date	Calibration Due Date
1	Test Receiver	R&S	ESCI	101296	Sep.15,2014	Sep.14,2015
2	Trilog Broadband Antenna	SCHWARZBECK	VULB9160	9160-3325	Sep.15,2014	Sep.14,2015
3	Amplifier	Compliance pirection systems inc	PAP-0203	22024	Sep.15,2014	Sep.14,2015
4	Cable	HUBER+SUHNER	CBL2	525178	Sep.15,2014	Sep.14,2015

RF Conducted Testing						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1.	EMC Analyzer (9k~26.5GHz)	Agilent	E7405A	MY45114943	Sep.15,2014	Sep.14,2015
2.	Spectrum Analyzer (9k-6GHz)	R&S	FSL6	100959	Sep.15,2014	Sep.14,2015
3.	Signal Analyzer (9k~26.5GHz)	Agilent	N9010A	MY50520207	Sep.15,2014	Sep.14,2015

5.2 Measurement Uncertainty

Parameter	Uncertainty
Radio Frequency	$\pm 1 \times 10^{-6}$
RF Power	± 1.0 dB
RF Power Density	± 2.2 dB
Radiated Spurious Emissions test	± 5.03 dB (Bilog antenna 30M~1000MHz)
	± 5.47 dB (Horn antenna 1000M~25000MHz)
Conducted Spurious Emissions test	± 3.64 dB (AC mains 150KHz~30MHz)

5.3 Test Equipment Calibration

All the test equipments used are valid and calibrated by CEPREI Certification Body that address is No.110 Dongguan Zhuang RD. Guangzhou, P.R.China.

6 Conducted Emission

Test Requirement:	FCC CFR 47 Part 15 Section 15.207
Test Method:	ANSI C63.4:2003
Test Result:	PASS
Frequency Range:	150kHz to 30MHz
Class/Severity:	Class B
Limit:	66-56 dB μ V between 0.15MHz & 0.5MHz 56 dB μ V between 0.5MHz & 5MHz 60 dB μ V between 5MHz & 30MHz
Detector:	Peak for pre-scan (9kHz Resolution Bandwidth)

6.1 E.U.T. Operation

Operating Environment :

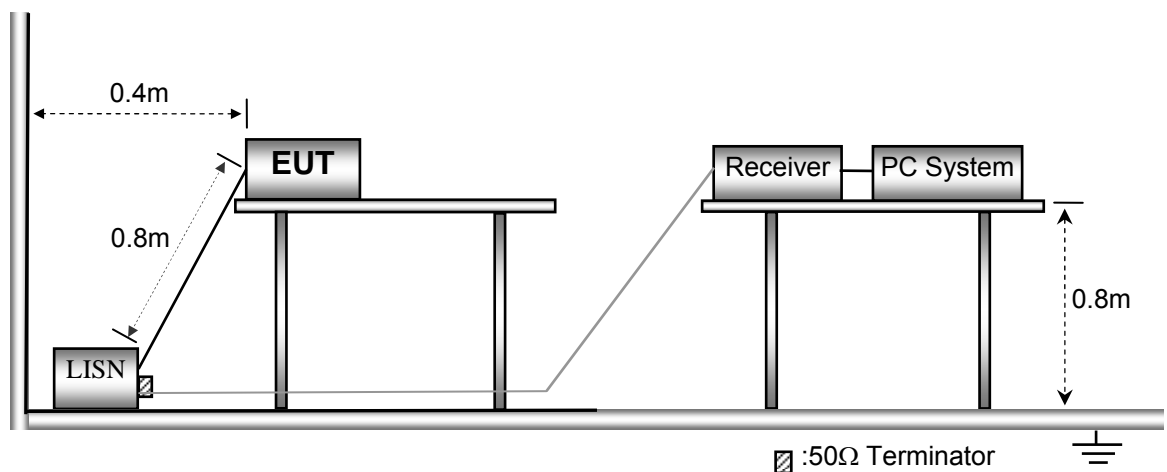
Temperature:	25.5 °C
Humidity:	51 % RH
Atmospheric Pressure:	101.2kPa

EUT Operation :

The test was performed in transmitting mode, the test data were shown in the report.

6.2 EUT Setup

The conducted emission tests were performed using the setup accordance with the ANSI C63.4:2003.

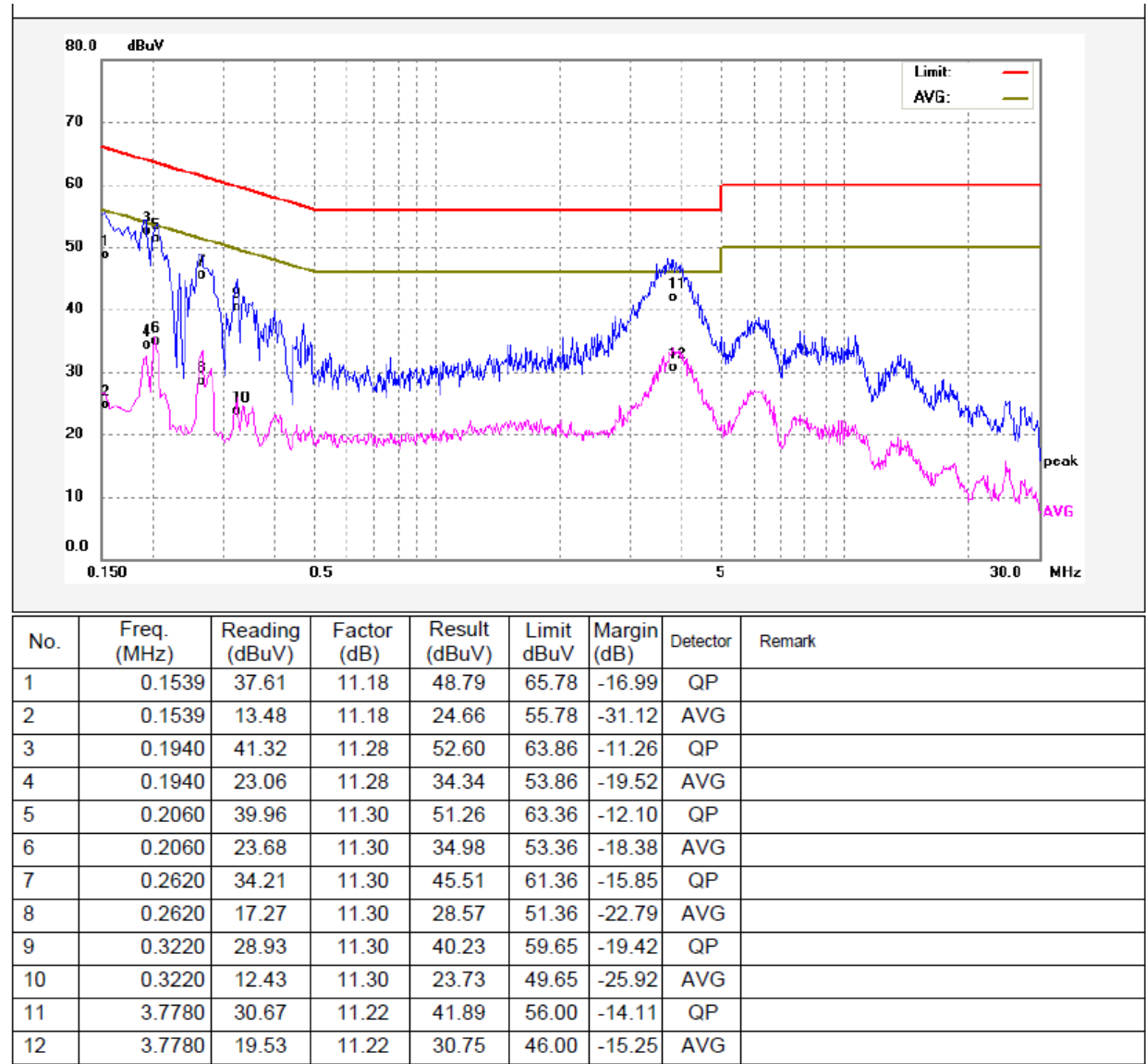


6.3 Measurement Description

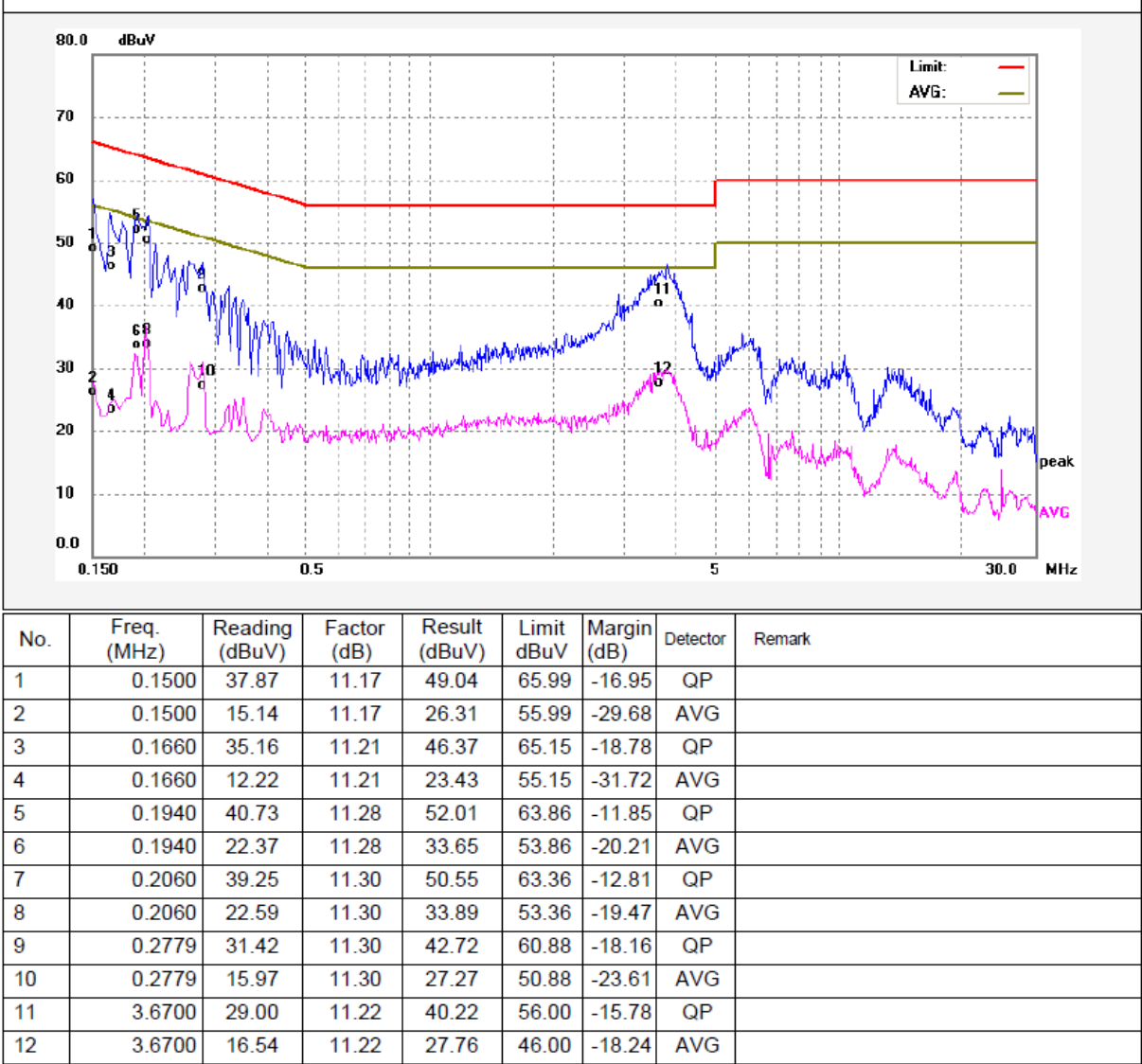
The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

6.4 Conducted Emission Test Result

Live line:



Neutral line:



7 Radiated Spurious Emissions

Test Requirement: FCC CFR47 Part 15 Section 15.209 & 15.247

Test Method: DA 00-705

Test Result: PASS

Measurement Distance: 3m

Limit:

Frequency (MHz)	Field Strength		Field Strength Limit at 3m Measurement Dist	
	uV/m	Distance (m)	uV/m	dBuV/m
0.009 ~ 0.490	2400/F(kHz)	300	$10000 * 2400/F(\text{kHz})$	$20\log^{(2400/F(\text{kHz}))} + 80$
0.490 ~ 1.705	24000/F(kHz)	30	$100 * 24000/F(\text{kHz})$	$20\log^{(24000/F(\text{kHz}))} + 40$
1.705 ~ 30	30	30	$100 * 30$	$20\log^{(30)} + 40$
30 ~ 88	100	3	100	$20\log^{(100)}$
88 ~ 216	150	3	150	$20\log^{(150)}$
216 ~ 960	200	3	200	$20\log^{(200)}$
Above 960	500	3	500	$20\log^{(500)}$

7.1 EUT Operation

Operating Environment :

Temperature: 23.5 °C

Humidity: 51.1 % RH

Atmospheric Pressure: 101.2kPa

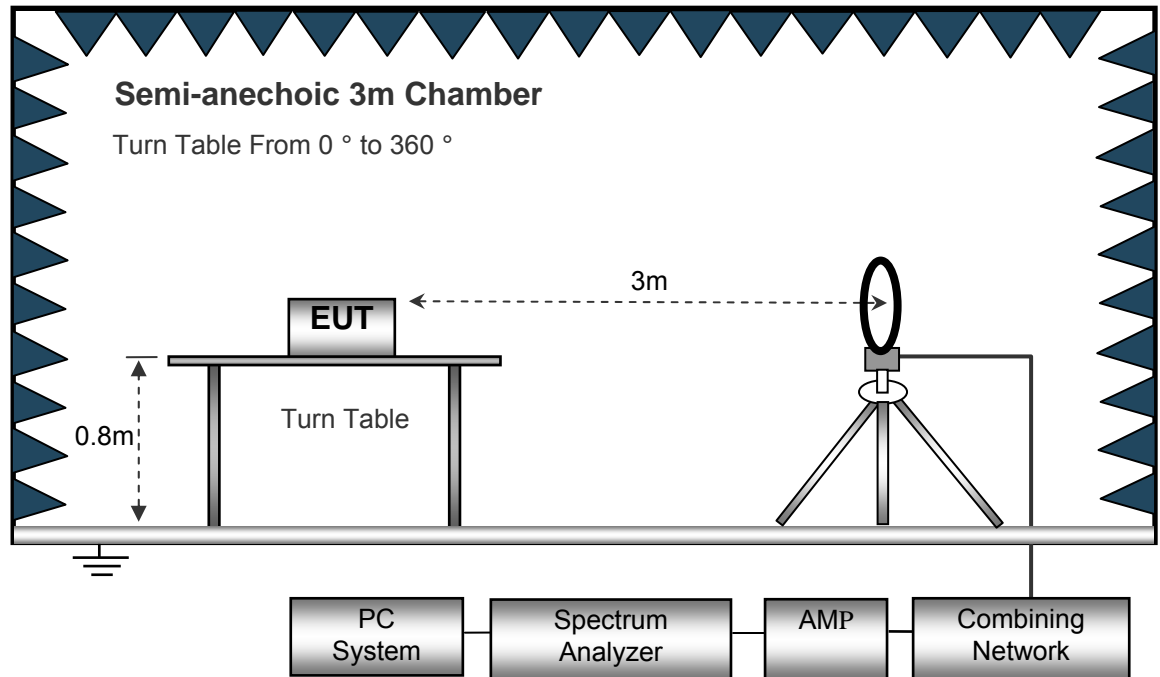
EUT Operation :

The test was performed in transmitting mode, the test data were shown in the report.

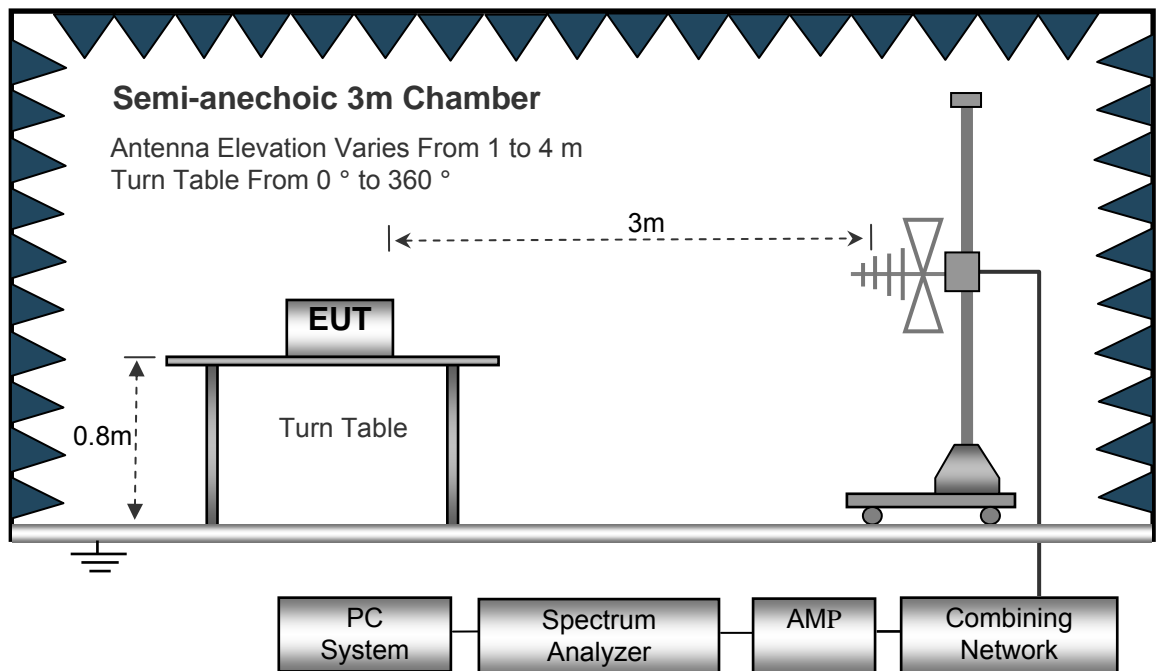
7.2 Test Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the ANSI C63.4: 2003.

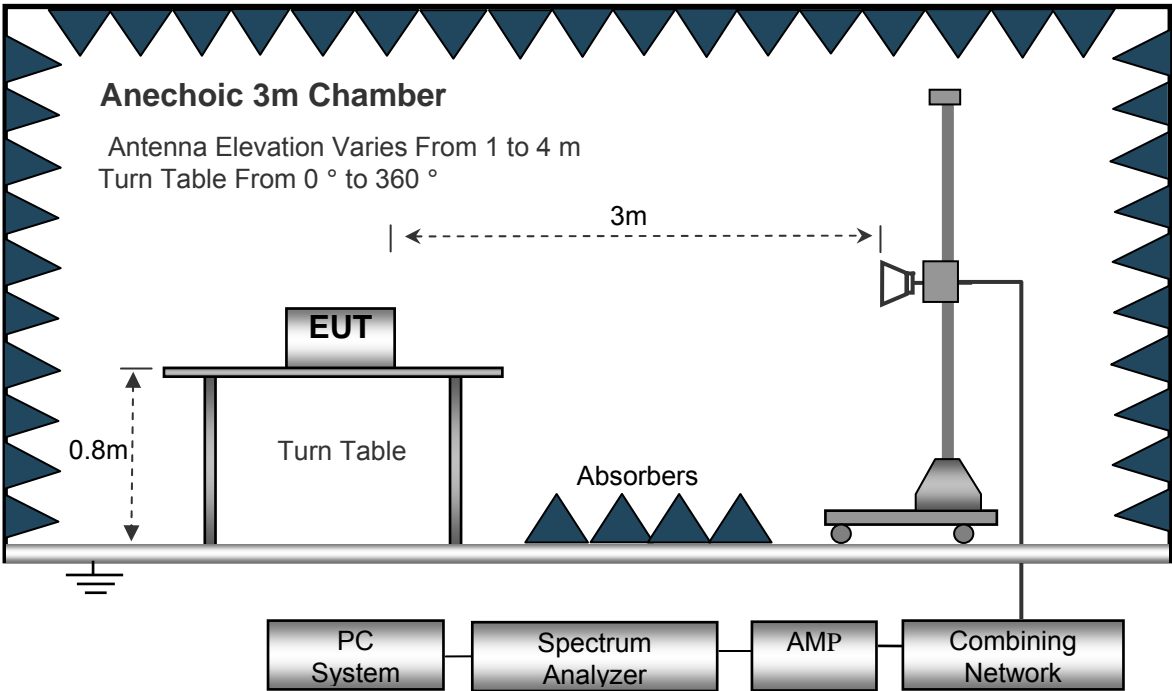
The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



The test setup for emission measurement above 1 GHz.



7.3 Spectrum Analyzer Setup

Below 30MHz

Sweep Speed Auto
IF Bandwidth.....10kHz
Video Bandwidth.....10kHz
Resolution Bandwidth..... 10kHz

30MHz ~ 1GHz

Sweep Speed Auto
DetectorPK
Resolution Bandwidth..... 100kHz
Video Bandwidth.....300kHz

Above 1GHz

Sweep Speed Auto
DetectorPK
Resolution Bandwidth..... 1MHz
Video Bandwidth.....3MHz
DetectorAve.
Resolution Bandwidth..... 1MHz
Video Bandwidth..... 10Hz

7.4 Test Procedure

1. The EUT is placed on a turntable, which is 0.8m above ground plane.
2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions. The spectrum was investigated from the lowest radio frequency signal generated in the device, without going below 9 kHz, up to the tenth harmonic of the highest fundamental frequency or to 40 GHz, whichever is lower.
4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
6. Repeat above procedures until the measurements for all frequencies are complete.
7. The radiation measurements are tested under 3-axes(X,Y,Z) position(X denotes lying on the table, Y denotes side stand and Z denotes vertical stand), After pre-test, It was found that the worse radiation emission was get at the X position. So the data shown was the X position only.

7.5 Summary of Test Results

Test Frequency: 16MHz~30MHz

The measurements were more than 20 dB below the limit and not reported.

Test Frequency: 30MHz ~ 18GHz

Remark: only the worst data(GFSK modulation mode) were reported.

Frequency	Receiver Reading	Detector	Turn table Angle	RX Antenna		Corrected Factor	Corrected Amplitude	Limit	Margin
				Height	Polar				
(MHz)	(dBμV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBμV/m)	(dBμV/m)	(dB)
GFSK Low Channel									
175.65	20.56	QP	225	1.5	H	10.52	31.08	43.65	-12.57
175.65	18.74	QP	242	1.9	V	10.52	29.26	43.65	-14.39
4804.00	52.91	PK	235	1.1	V	-1.63	51.28	74.00	-22.72
4804.00	44.55	Ave	235	1.1	V	-1.63	42.92	54.00	-11.08
7206.00	53.01	PK	85	1.9	H	1.35	54.36	74.00	-19.64
7206.00	42.51	Ave	85	1.9	H	1.35	43.86	54.00	-10.14
2340.16	46.61	PK	353	1.6	V	-13.18	33.43	74.00	-40.57
2340.16	38.42	Ave	353	1.6	V	-13.18	25.24	54.00	-28.76
2360.94	43.96	PK	251	1.9	H	-13.15	30.81	74.00	-43.19
2360.94	37.26	Ave	251	1.9	H	-13.15	24.11	54.00	-29.89
2486.42	43.26	PK	120	1.0	V	-13.07	30.19	74.00	-43.81
2486.42	38.77	Ave	120	1.0	V	-13.07	25.70	54.00	-28.30

Frequency	Receiver Reading	Detector	Turn table Angle	RX Antenna		Corrected Factor	Corrected Amplitude	Limit	Margin
				Height	Polar				
(MHz)	(dBμV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBμV/m)	(dBμV/m)	(dB)
GFSK Middle Channel									
175.65	22.76	QP	314	1.3	H	10.53	33.29	43.65	-10.36
175.65	19.15	QP	200	1.4	V	10.53	29.68	43.65	-13.97
4882.00	54.12	PK	186	1.5	V	-0.59	53.53	74.00	-20.47
4882.00	40.27	Ave	186	1.5	V	-0.59	39.68	54.00	-14.32
7323.00	52.64	PK	114	1.7	H	2.23	54.87	74.00	-19.13
7323.00	44.62	Ave	114	1.7	H	2.23	46.85	54.00	-7.15
2343.31	45.03	PK	230	1.1	V	-13.18	31.85	74.00	-42.15
2343.31	38.64	Ave	230	1.1	V	-13.18	25.46	54.00	-28.54
2362.27	43.54	PK	67	1.1	H	-13.15	30.39	74.00	-43.61
2362.27	36.54	Ave	67	1.1	H	-13.15	23.39	54.00	-30.61
2483.63	43.35	PK	97	1.8	V	-13.09	30.26	74.00	-43.74
2483.63	36.73	Ave	97	1.8	V	-13.09	23.64	54.00	-30.36

Frequency	Receiver Reading	Detector	Turn table Angle	RX Antenna		Corrected Factor	Corrected Amplitude	Limit	Margin
				Height	Polar				
(MHz)	(dBμV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBμV/m)	(dBμV/m)	(dB)
GFSK High Channel									
175.65	22.67	QP	155	1.2	H	10.53	33.20	43.65	-10.45
175.65	18.87	QP	344	1.0	V	10.53	29.40	43.65	-14.25
4960.00	51.30	PK	260	1.7	V	-0.23	51.07	74.00	-22.93
4960.00	41.37	Ave	260	1.7	V	-0.23	41.14	54.00	-12.86
7440.00	54.52	PK	160	2.0	H	2.85	57.37	74.00	-16.63
7440.00	43.08	Ave	160	2.0	H	2.85	45.93	54.00	-8.07
2337.84	45.33	PK	118	1.2	V	-13.18	32.15	74.00	-41.85
2337.84	38.31	Ave	118	1.2	V	-13.18	25.13	54.00	-28.87
2351.86	42.73	PK	13	1.1	H	-13.16	29.57	74.00	-44.43
2351.86	38.37	Ave	13	1.1	H	-13.16	25.21	54.00	-28.79
2496.81	44.20	PK	68	1.1	V	-13.07	31.13	74.00	-42.87
2496.81	37.28	Ave	68	1.1	V	-13.07	24.21	54.00	-29.79

Test Frequency: 18GHz~25GHz

The measurements were more than 20 dB below the limit and not reported.

8 Band Edge Measurement

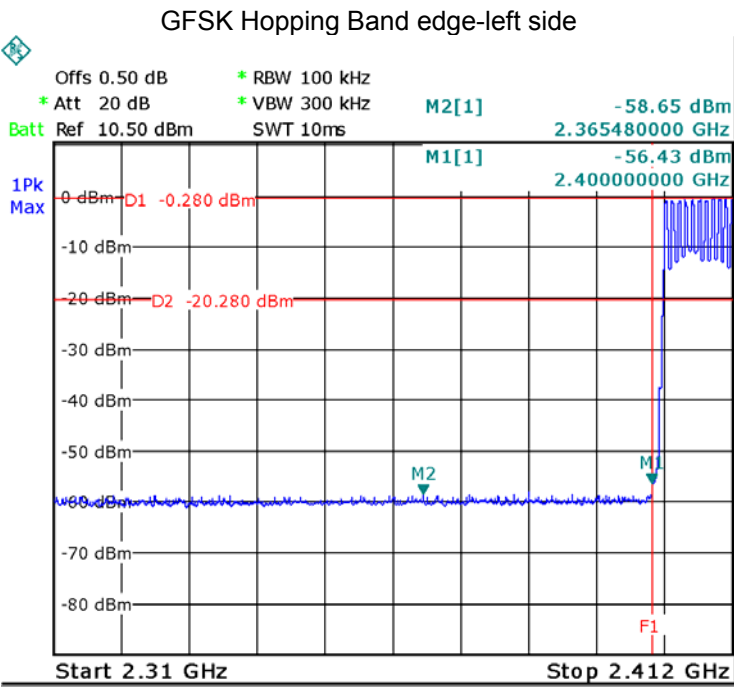
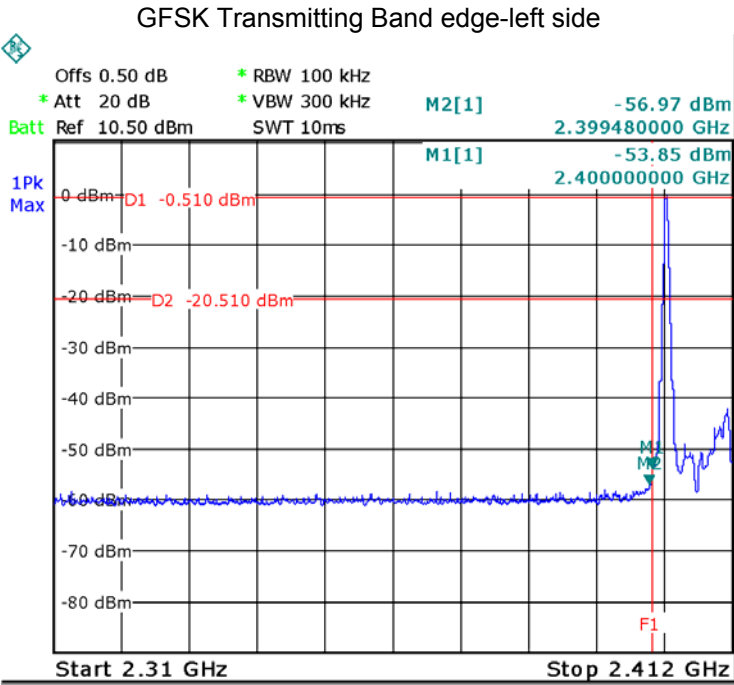
Test Requirement:	Section 15.247(d) In addition, radiated emissions which fall in the restricted bands. as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 15.205(c)).
Test Method:	DA 00-705
Test Mode:	Transmitting and Hopping

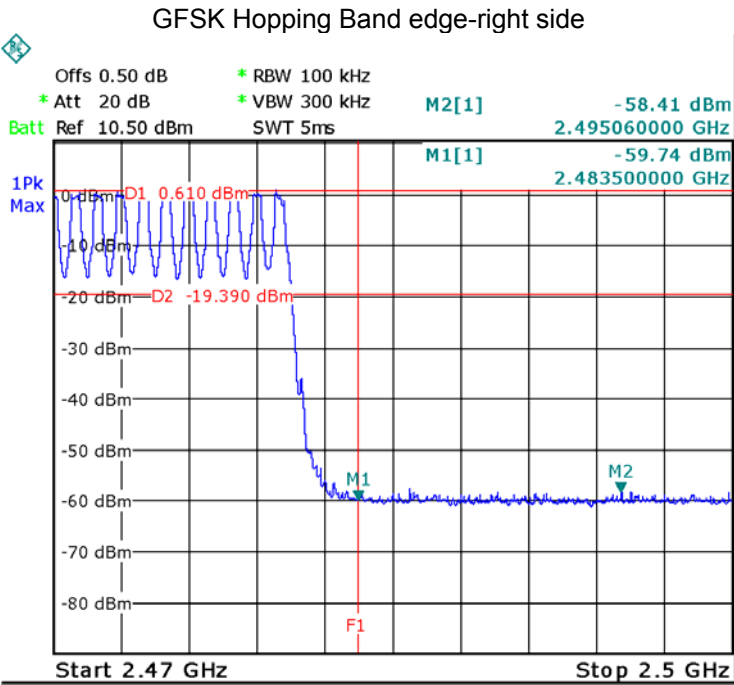
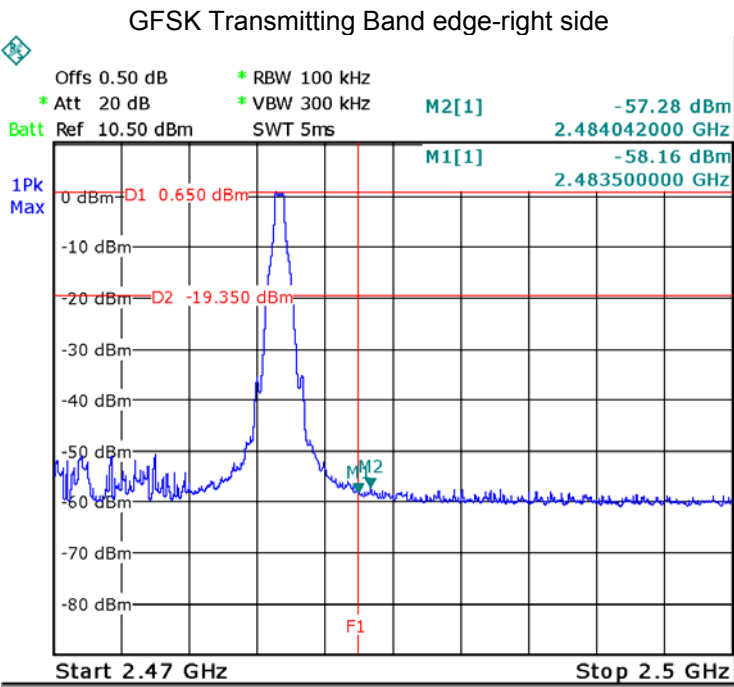
8.1 Test Procedure

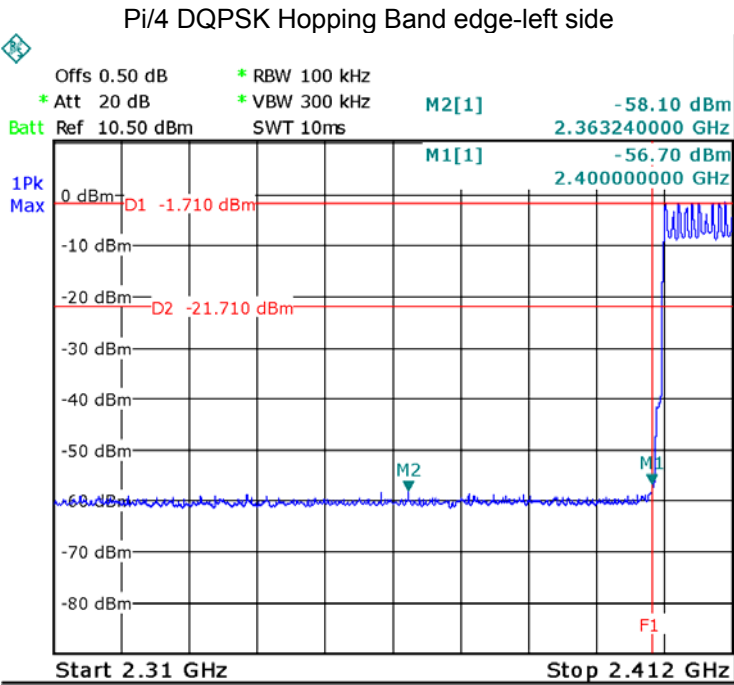
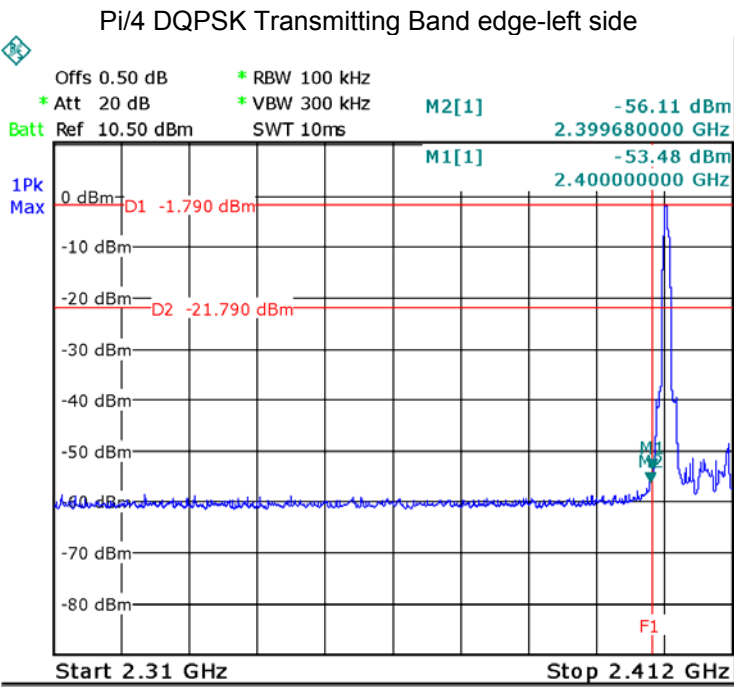
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;
2. Set the spectrum analyzer: RBW = 100kHz, VBW = 300kHz, Sweep = auto
Detector function = peak, Trace = max hold

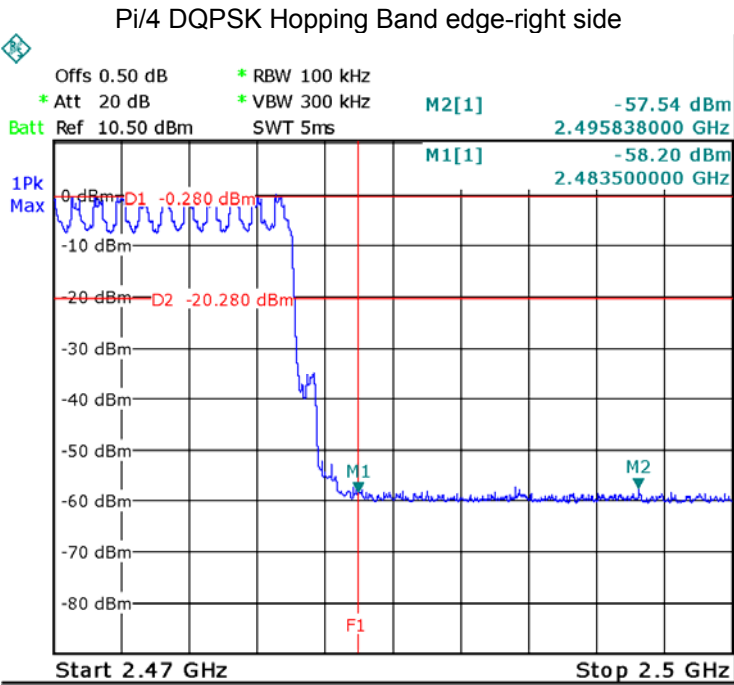
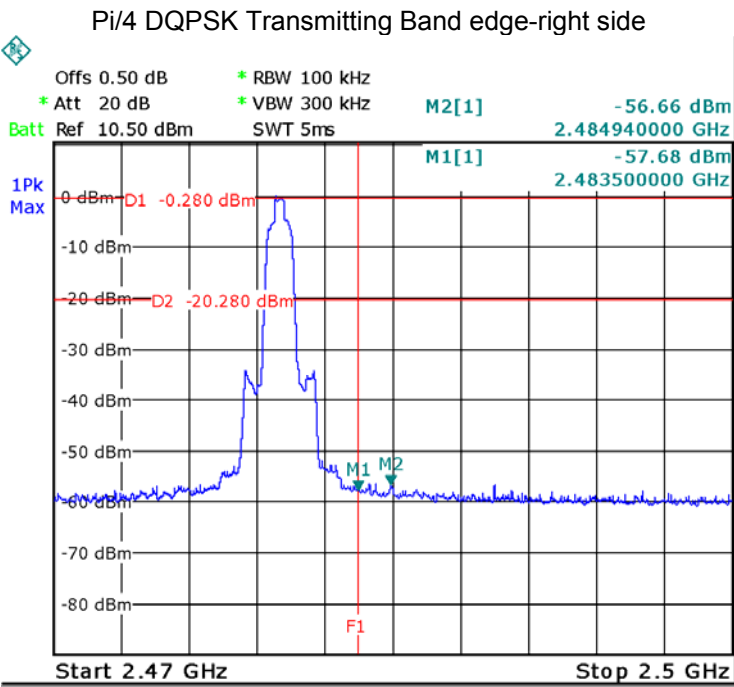
8.2 Test Result

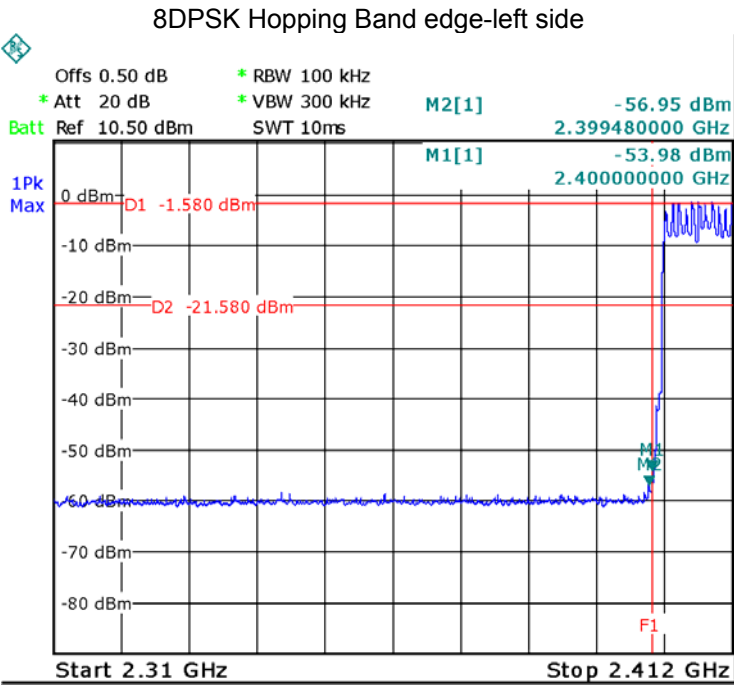
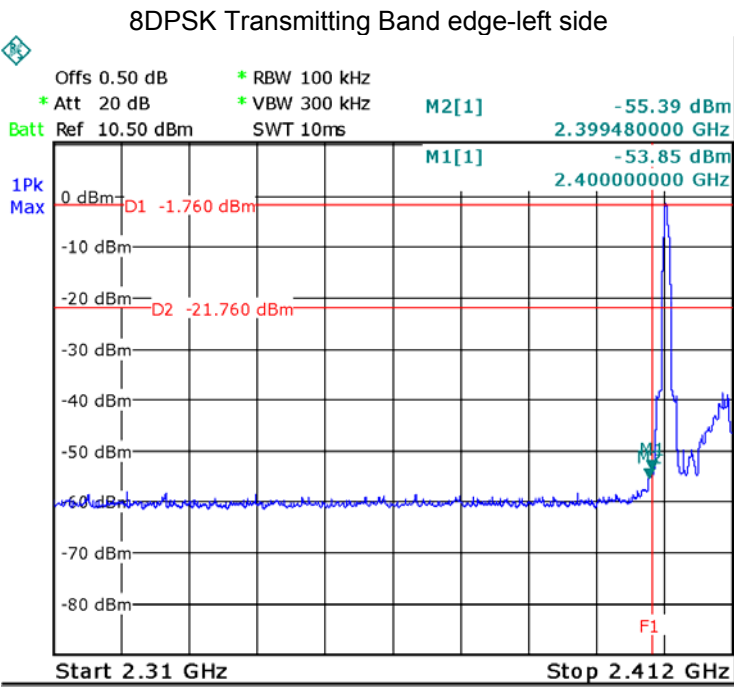
Test plots

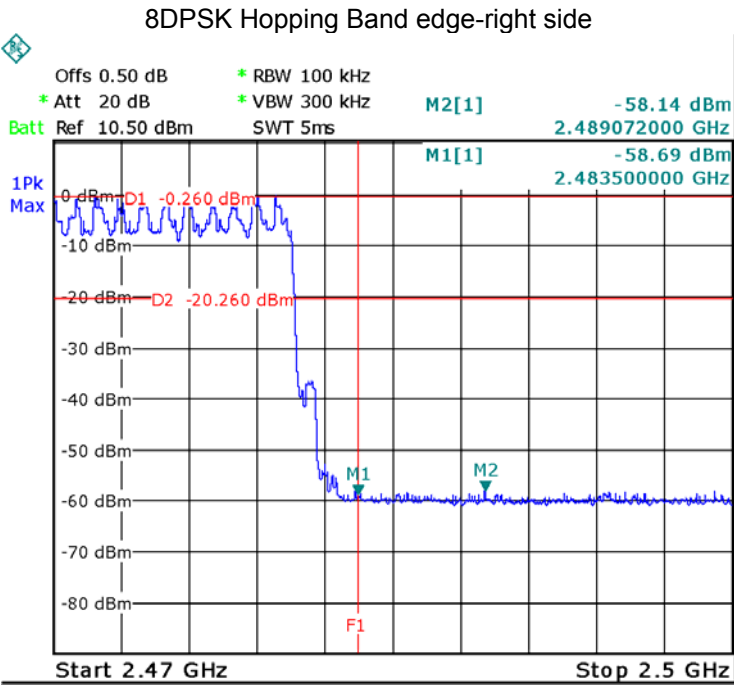
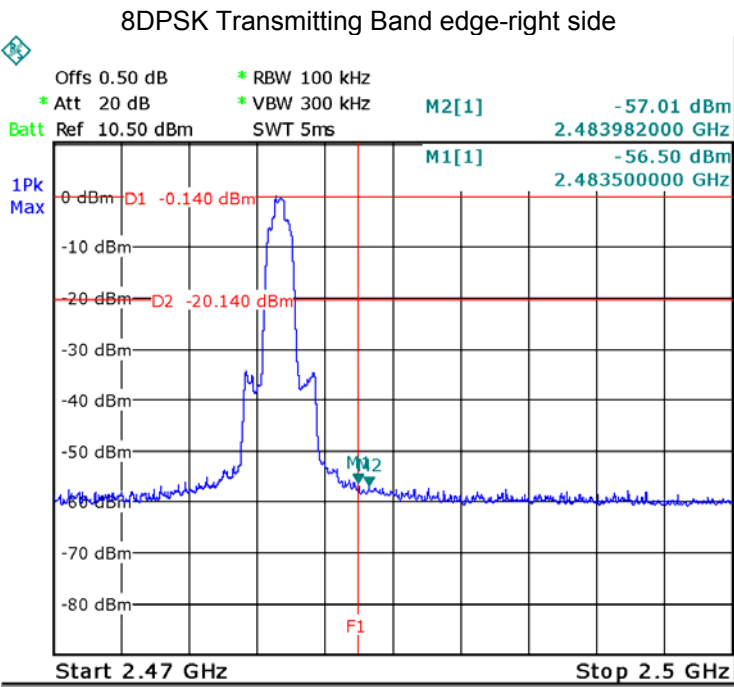












9 20 dB Bandwidth Measurement

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Mode: Test in fixing operating frequency at low, Middle, high channel.

9.1 Test Procedure

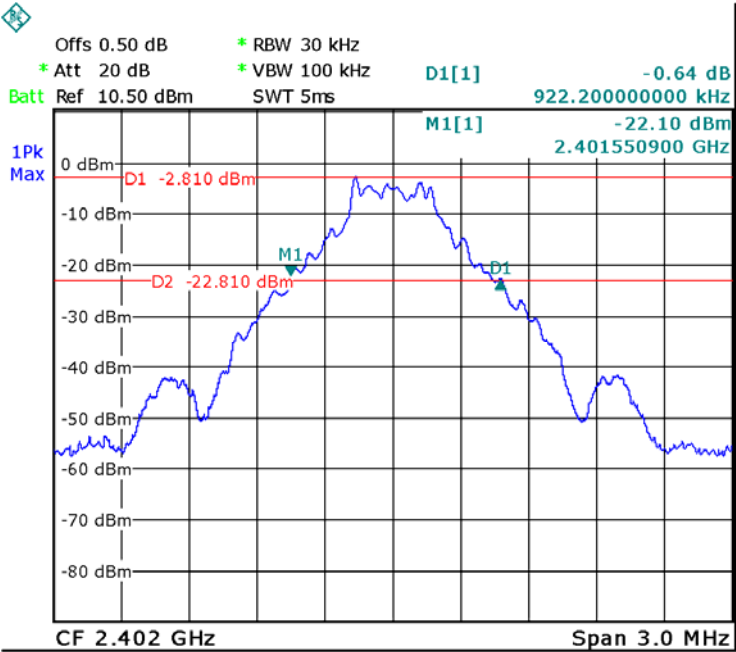
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;
2. Set the spectrum analyzer: RBW = 3kHz, VBW = 100kHz

9.2 Test Result

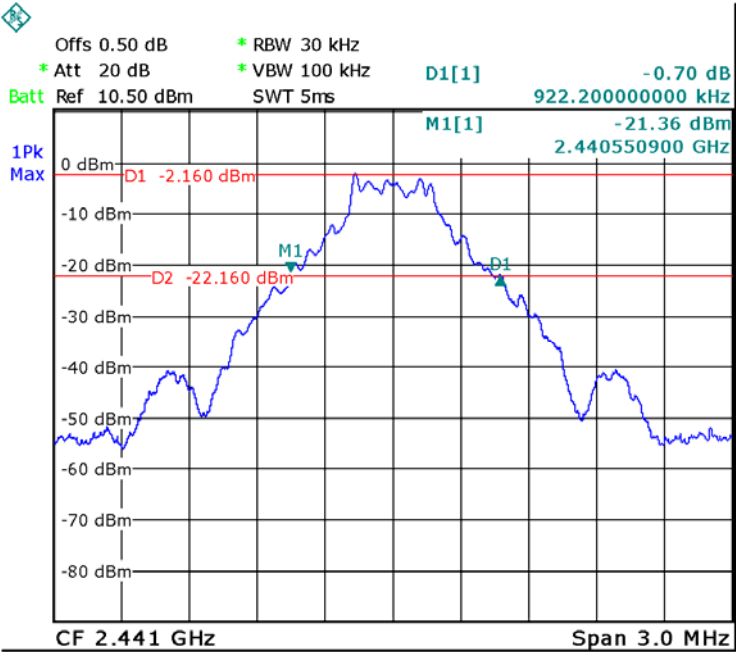
Modulation	Test Channel	Bandwidth(MHz)
GFSK	Low	0.922
GFSK	Middle	0.922
GFSK	High	0.922
Pi/4 DQPSK	Low	1.252
Pi/4 DQPSK	Middle	1.252
Pi/4 DQPSK	High	1.252
8DPSK	Low	1.258
8DPSK	Middle	1.258
8DPSK	High	1.258

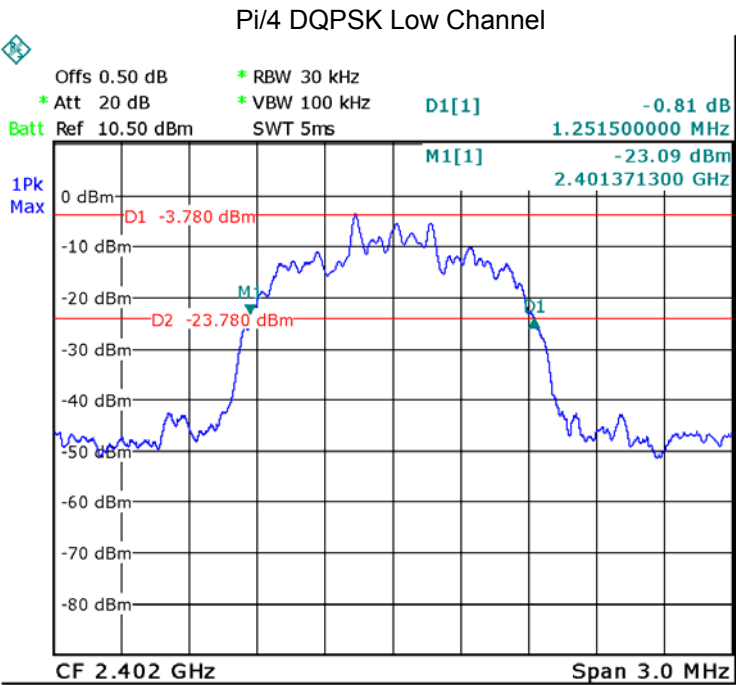
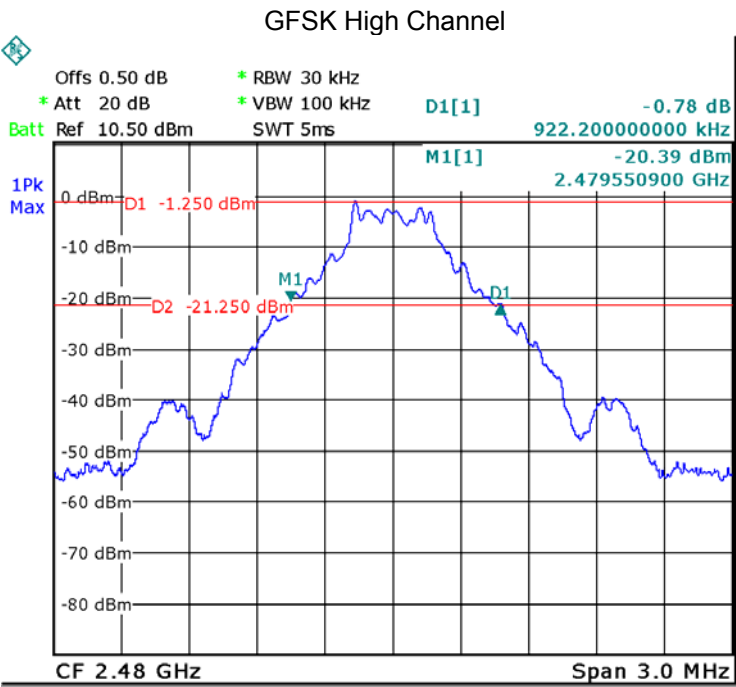
Test plots

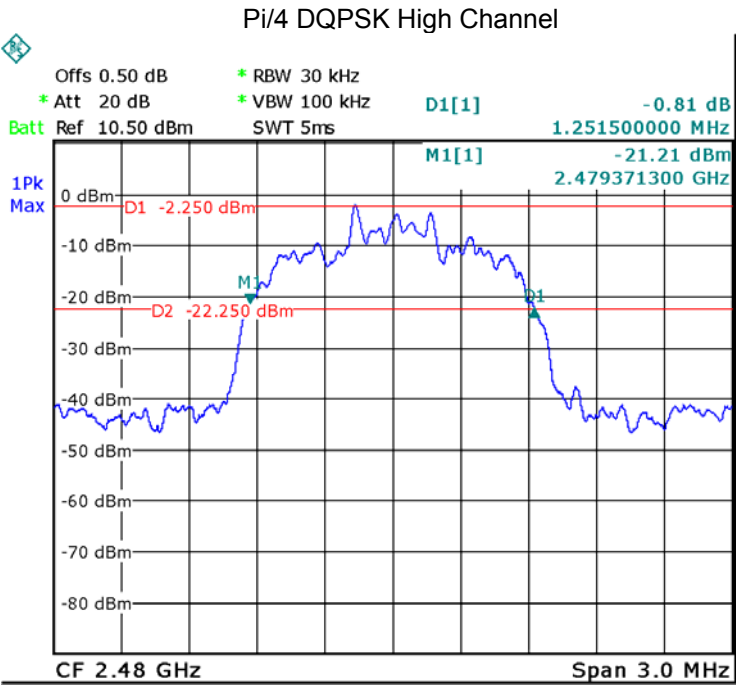
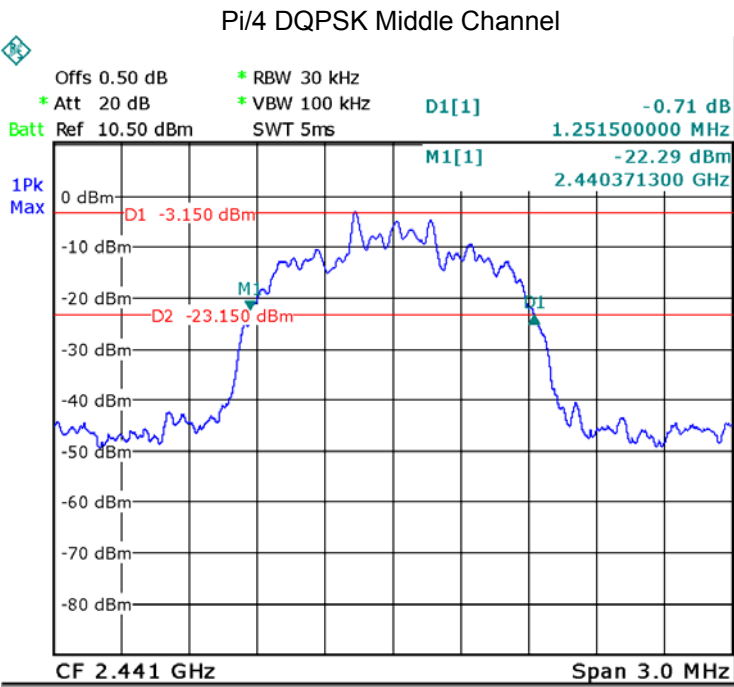
GFSK Low Channel

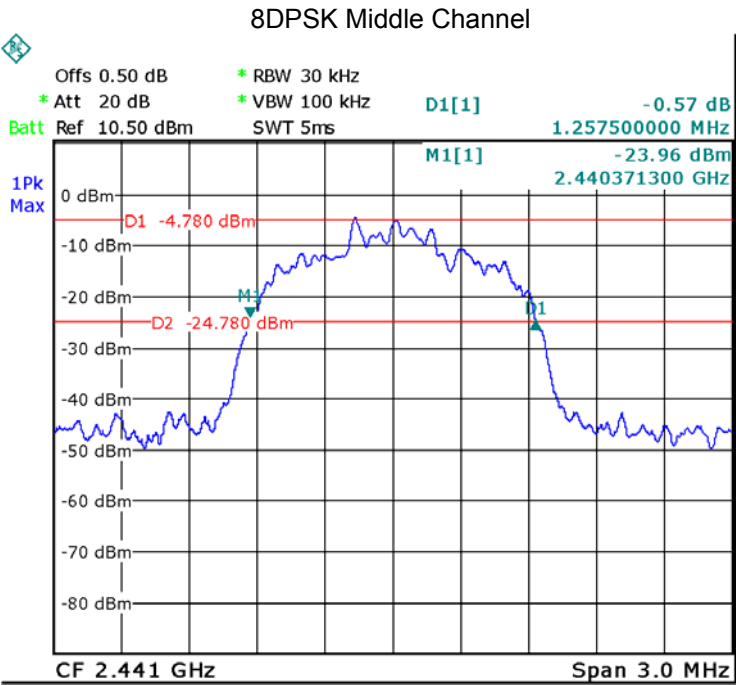
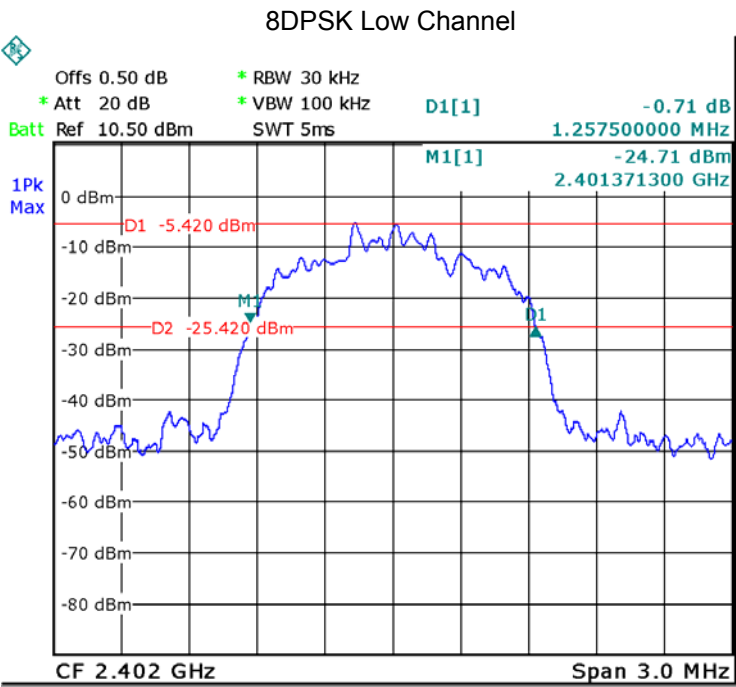


GFSK Middle Channel

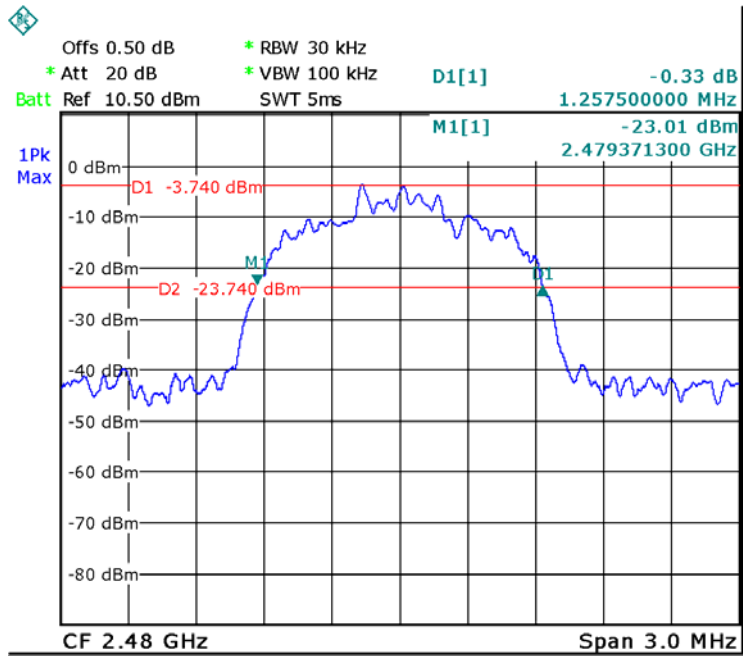








8DPSK High Channel



10 Maximum Peak Output Power

Test Requirement:	FCC CFR47 Part 15 Section 15.247
Test Method:	DA 00-705
Test Limit:	Regulation 15.247 (b)(1), For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts. Refer to the result "Number of Hopping Frequency" of this document. The 0.125watts (20.97 dBm) limit applies.
Test mode:	Test in fixing frequency transmitting mode.

10.1 Test Procedure

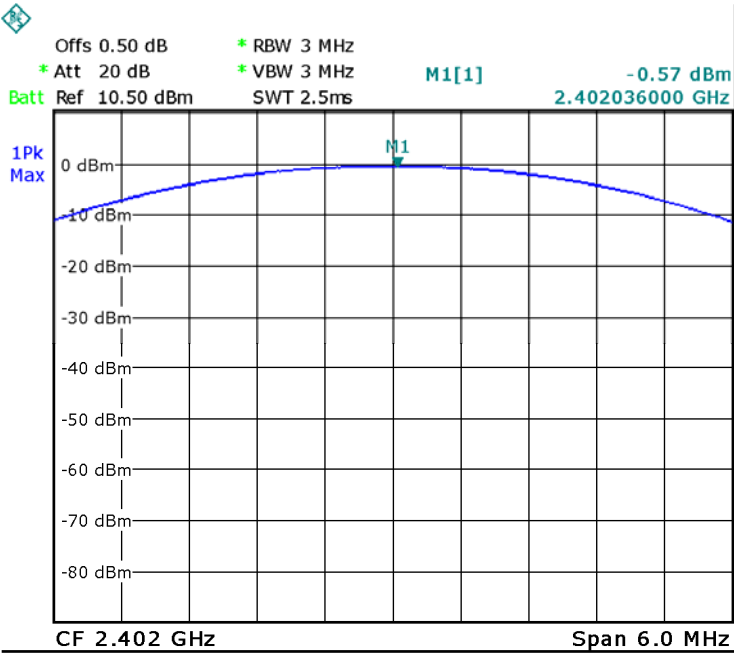
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.
2. Set the spectrum analyzer: RBW = 3MHz. VBW = 3MHz. Sweep = auto; Detector Function = Peak.
3. Keep the EUT in transmitting at lowest, medium and highest channel individually. Record the max value.

10.2 Test Result

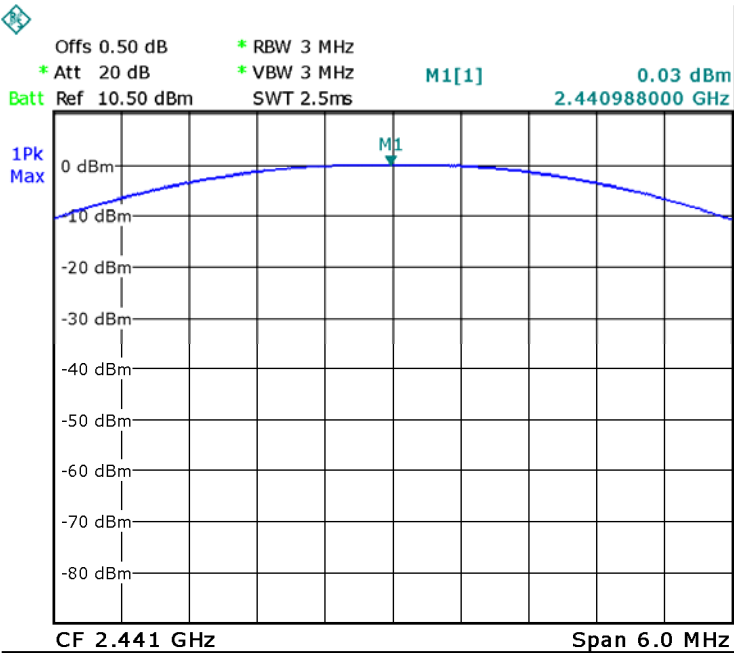
Modulation	Test Channel	Output Power (dBm)	Limit (dBm)
GFSK	Low	-0.57	30
GFSK	Middle	0.03	30
GFSK	High	0.86	30
Pi/4 DQPSK	Low	-0.75	21
Pi/4 DQPSK	Middle	-0.47	21
Pi/4 DQPSK	High	0.51	21
8DPSK	Low	-0.83	21
8DPSK	Middle	-0.70	21
8DPSK	High	0.30	21

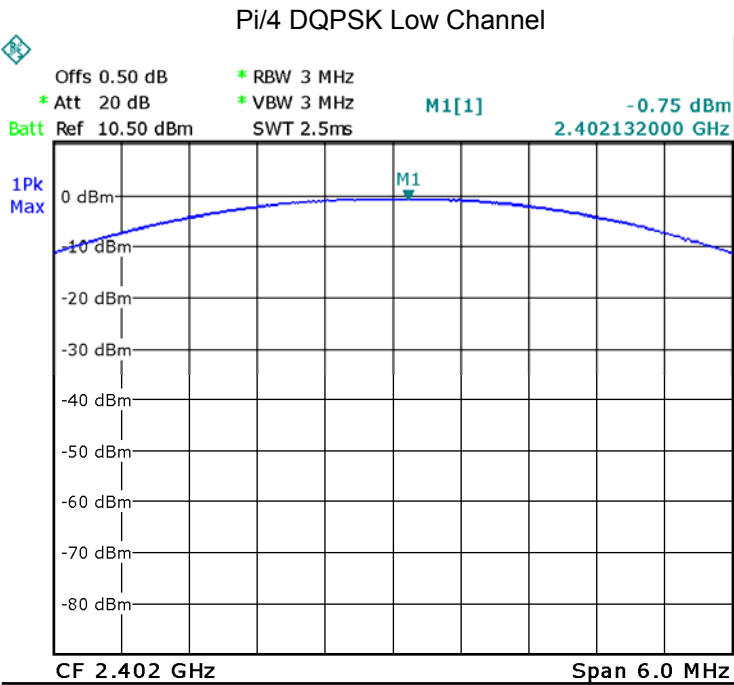
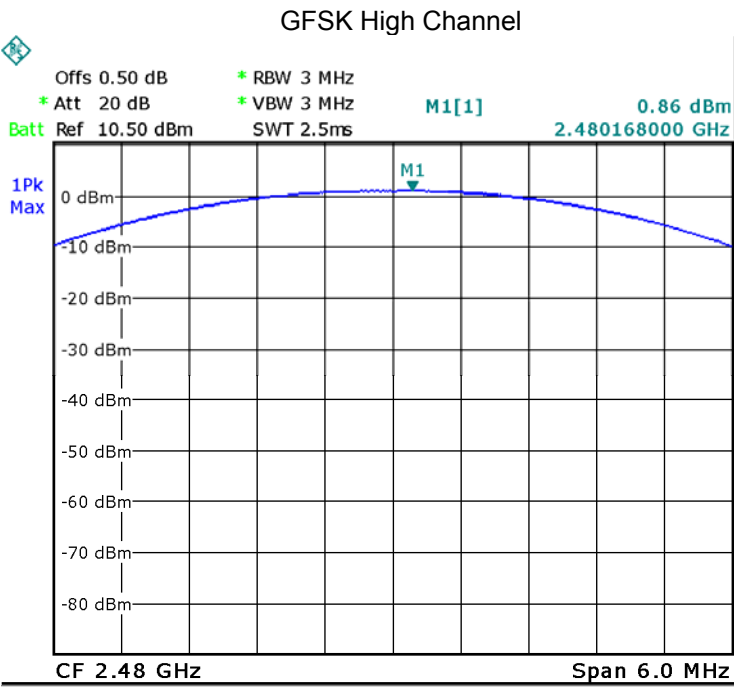
Test plots

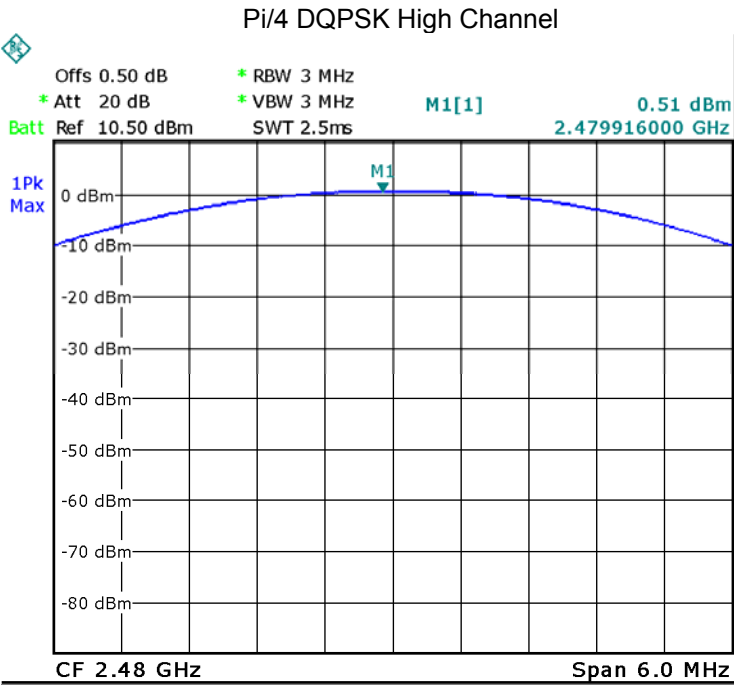
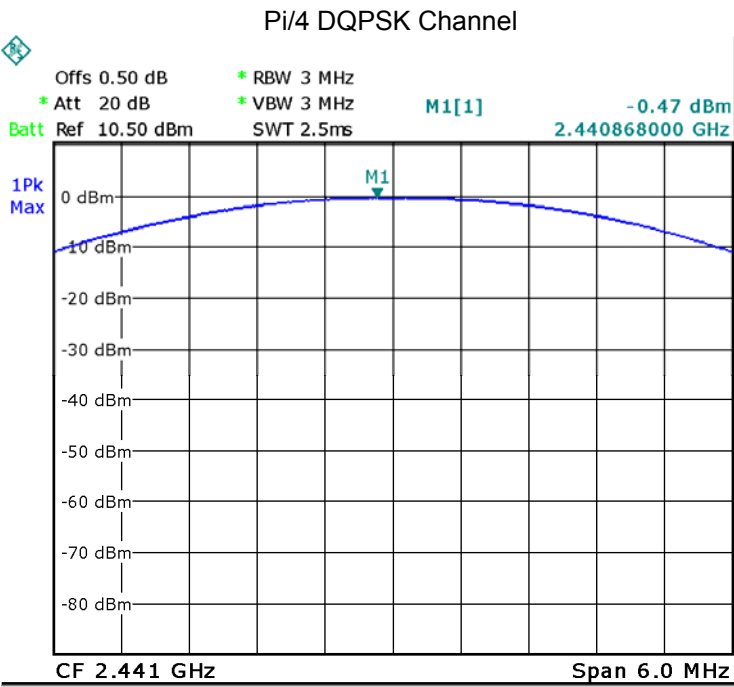
GFSK Low Channel

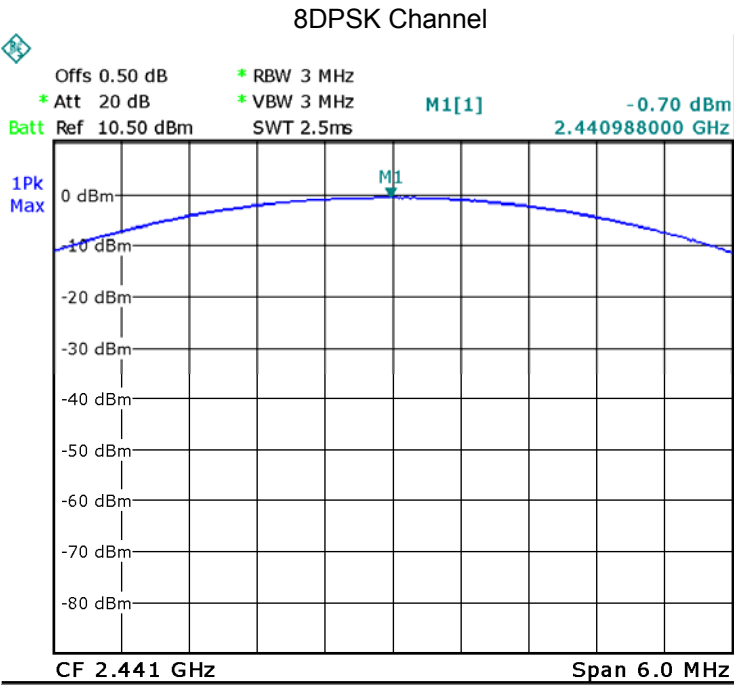
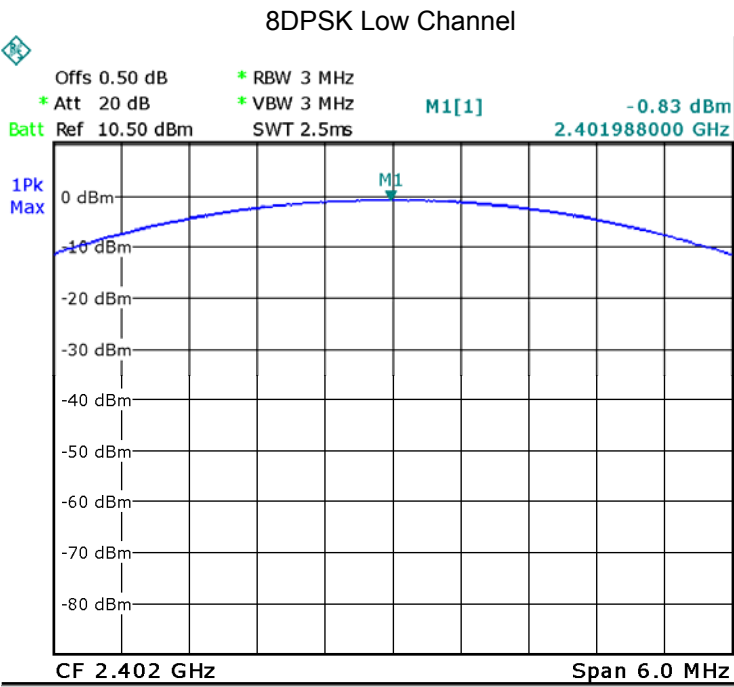


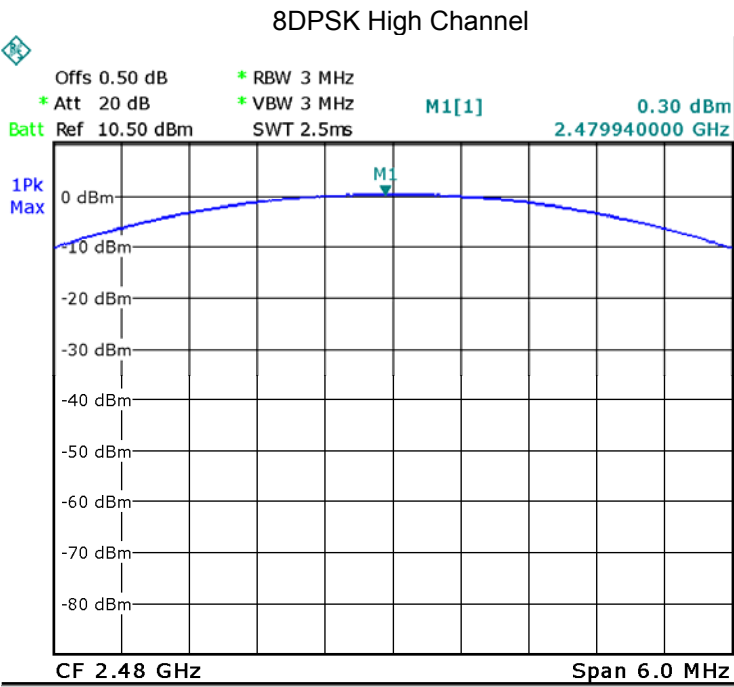
GFSK Channel











11 Hopping Channel Separation

Test Requirement:	FCC CFR47 Part 15 Section 15.247
Test Method:	DA 00-705
Test Limit:	Regulation 15.247(a)(1) Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 1W.
Test Mode:	Test in hopping transmitting operating mode.

11.1 Test Procedure

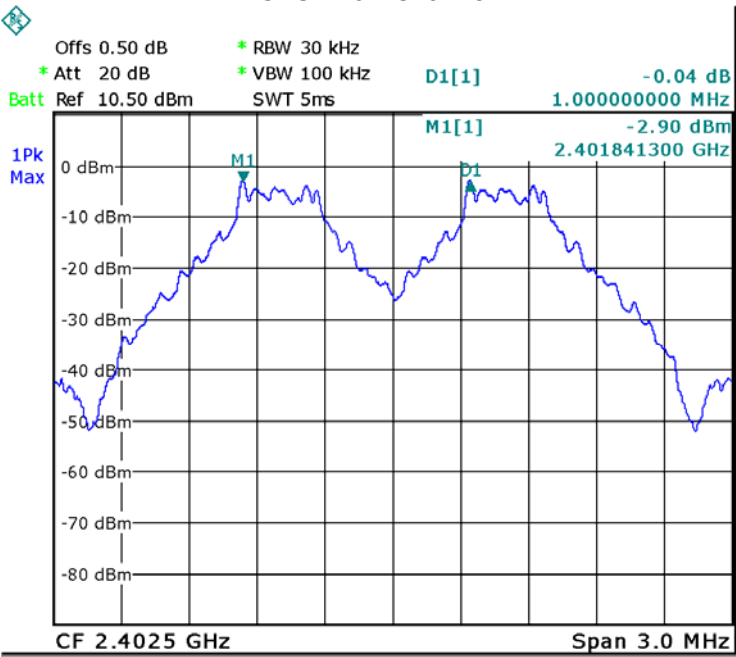
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.
2. Set the spectrum analyzer: RBW = 30kHz. VBW = 100kHz , Span = 3.0MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
3. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section Submit this plot.

11.2 Test Result

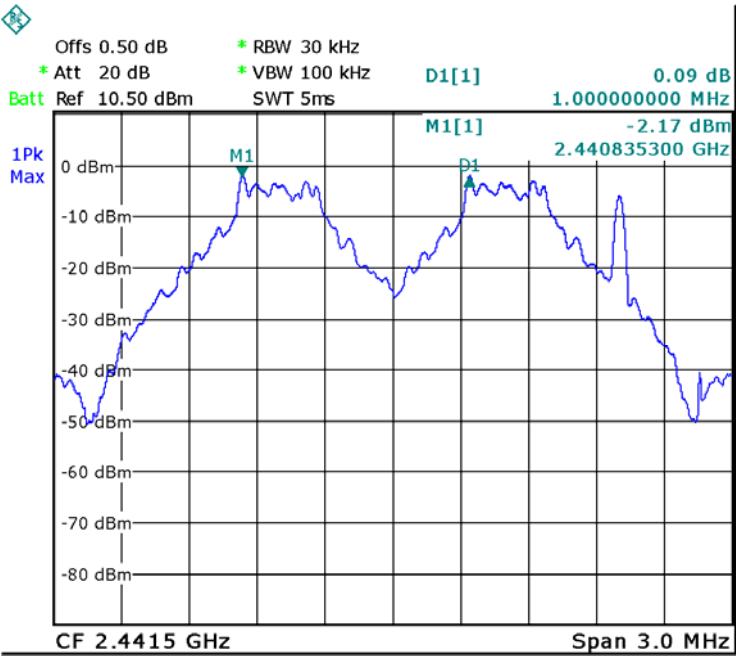
Modulation	Test Channel	Separation (MHz)	Result
GFSK	Low	1.000	PASS
GFSK	Middle	1.000	PASS
GFSK	High	1.000	PASS
Pi/4 DQPSK	Low	1.000	PASS
Pi/4 DQPSK	Middle	1.000	PASS
Pi/4 DQPSK	High	1.000	PASS
8DPSK	Low	1.000	PASS
8DPSK	Middle	1.000	PASS
8DPSK	High	1.000	PASS

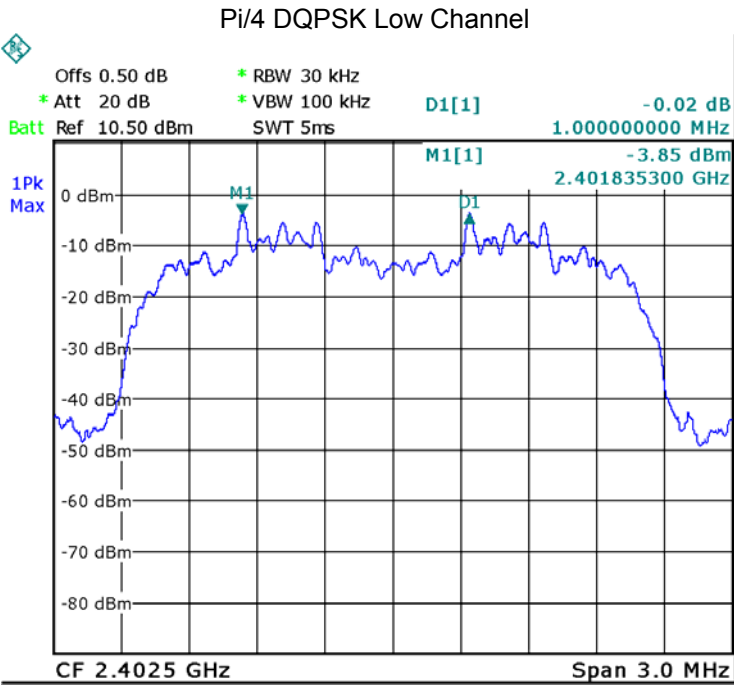
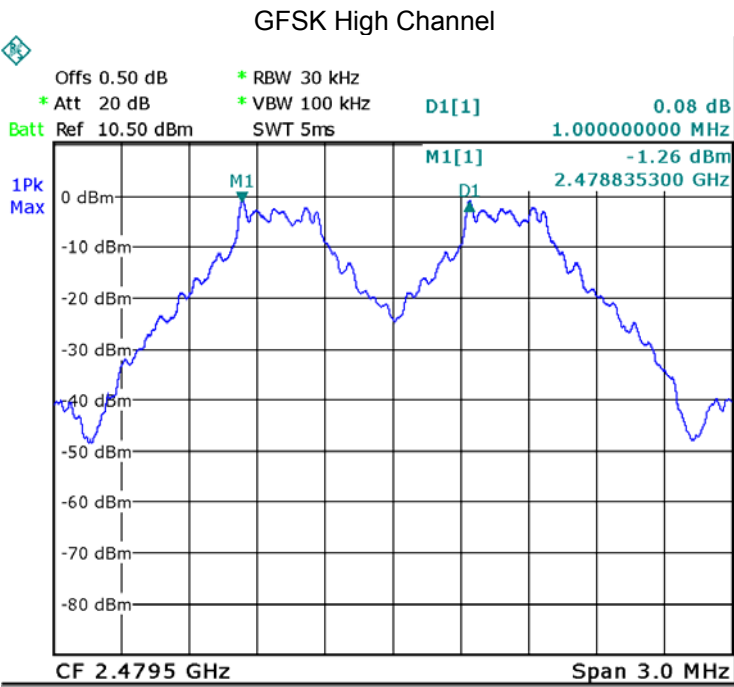
Test plots

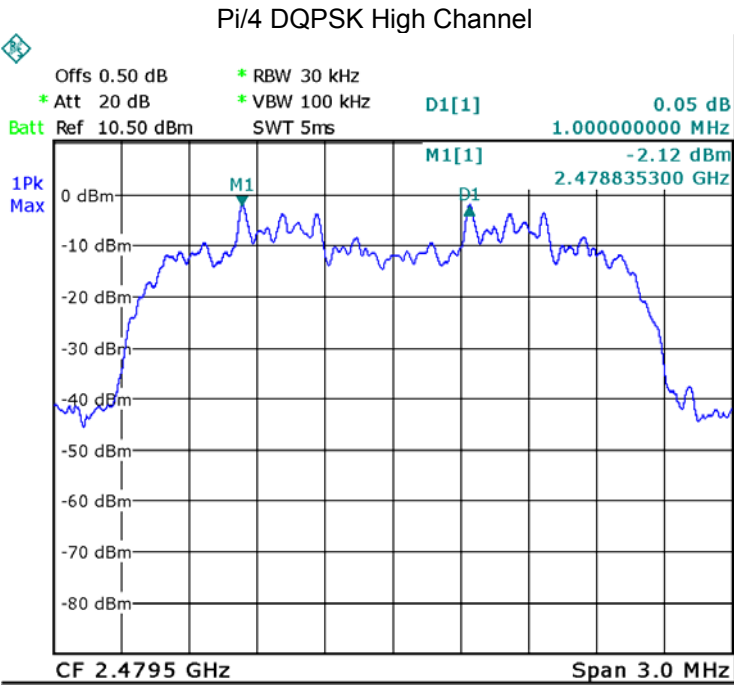
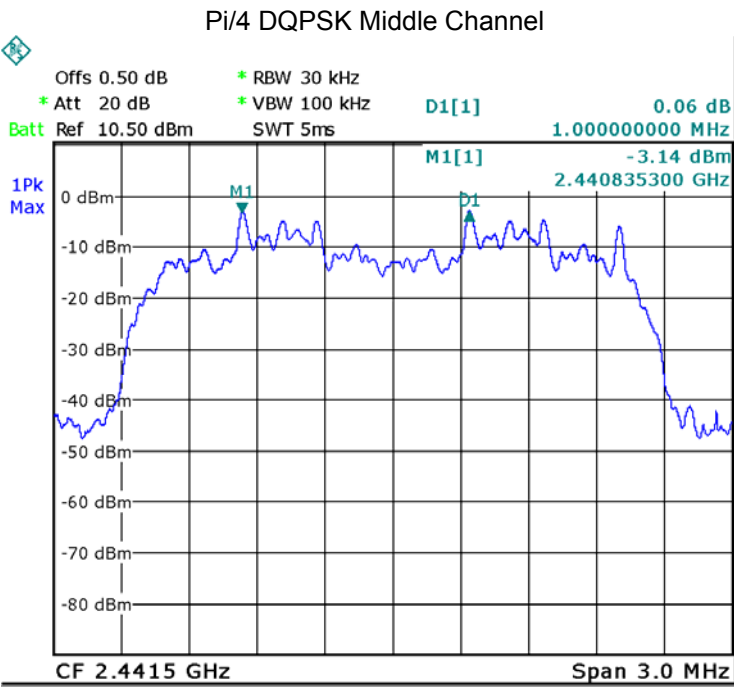
GFSK Low Channel

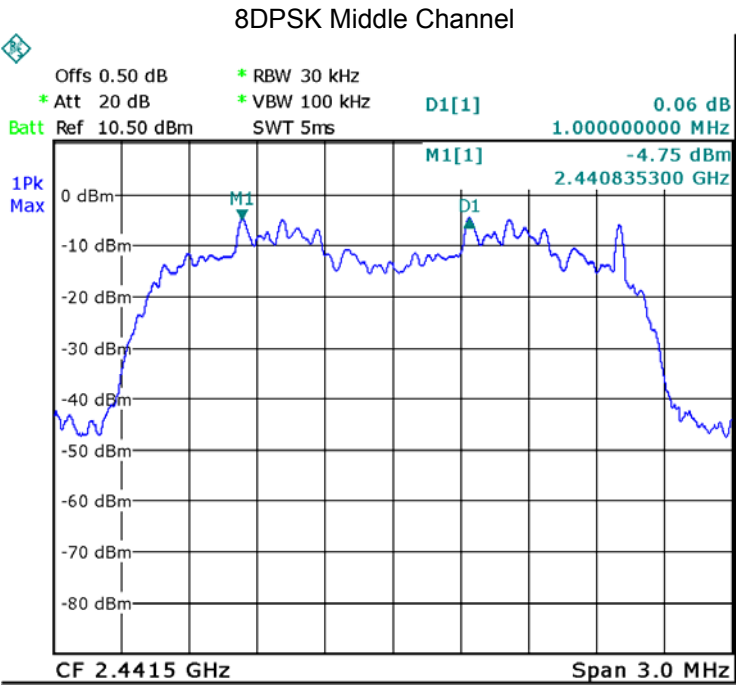
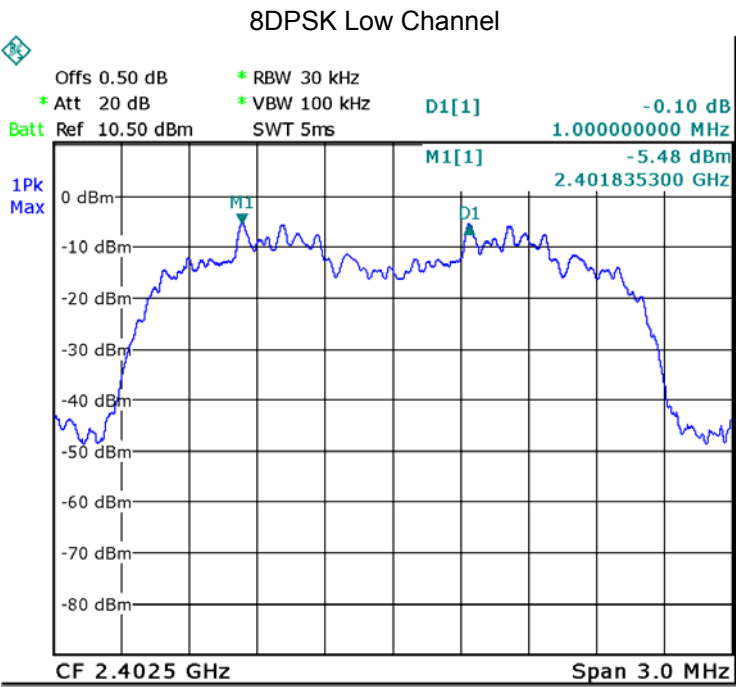


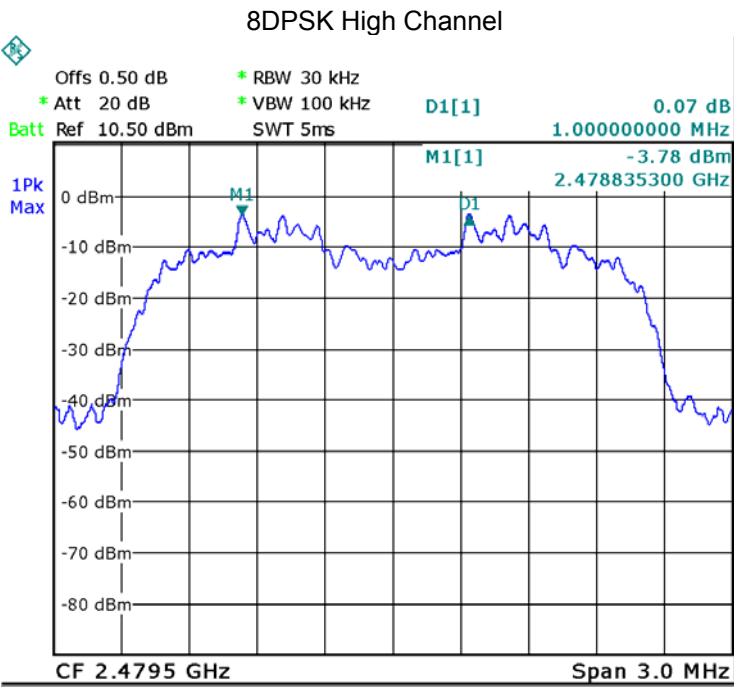
GFSK Middle Channel











12 Number of Hopping Frequency

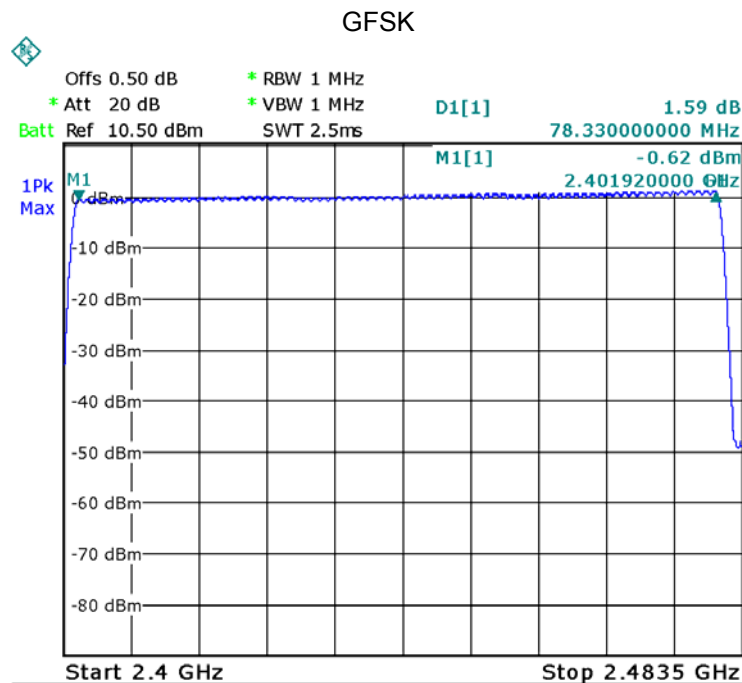
Test Requirement:	FCC CFR47 Part 15 Section 15.247
Test Method:	DA 00-705
Test Limit:	Regulation 15.247 (a)(1)(iii) Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.
Test Mode:	Test in hopping transmitting operating mode.

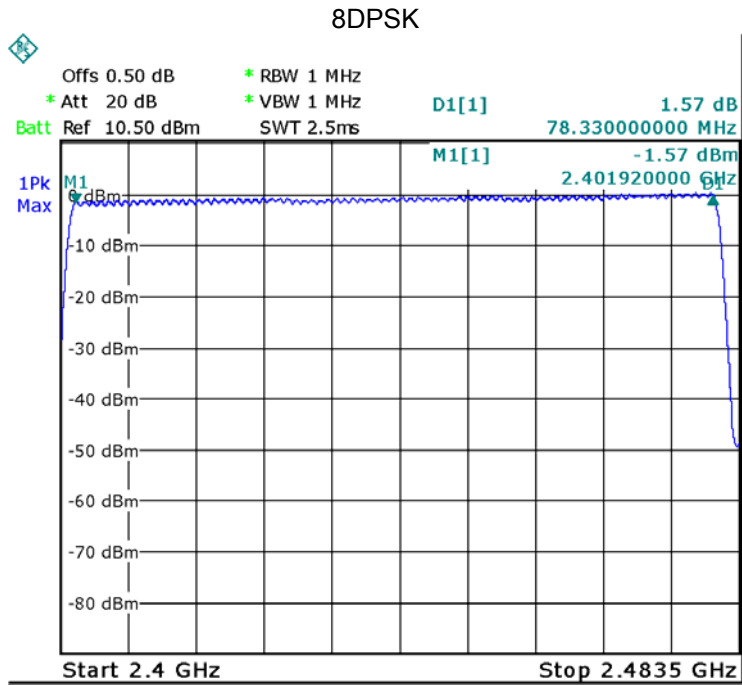
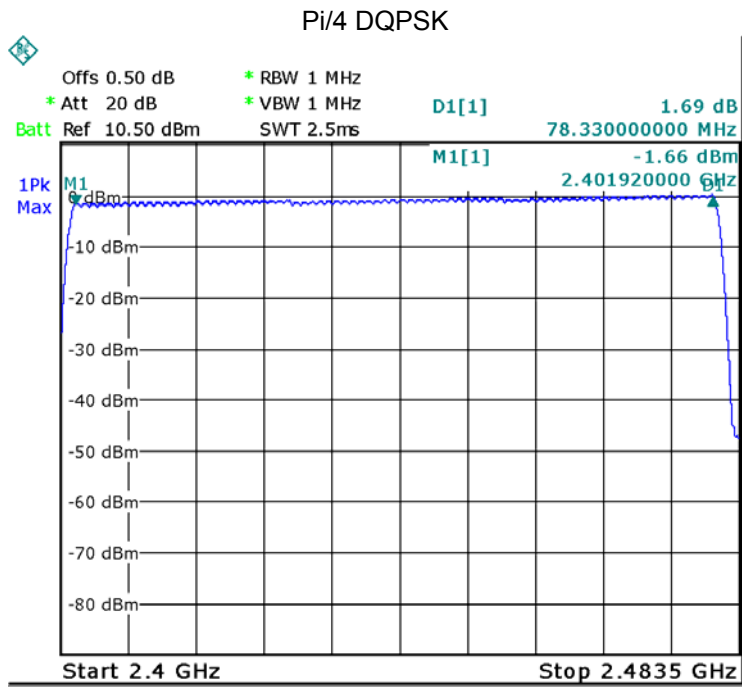
12.1 Test Procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.
2. Set the spectrum analyzer: RBW = 1MHz. VBW = 1MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
3. Allow the trace to stabilize. It may prove necessary to break the span up to sections. in order to clearly show all of the hopping frequencies. The limit is specified in one of the subparagraphs of this Section.
4. Set the spectrum analyzer: Start Frequency = 2.4GHz, Stop Frequency = 2.483GHz. Sweep=auto;

12.2 Test Result

Test Plot: 79 Channels in total





13 Dwell Time

Test Requirement:	FCC CFR47 Part 15 Section 15.247
Test Method:	DA 00-705
Test Limit:	Regulation 15.247(a)(1)(iii) Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Mode:	Test in hopping transmitting operating mode.

13.1 Test Procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.
2. Set spectrum analyzer span = 0. Centred on a hopping channel;
3. Set RBW = 1MHz and VBW = 3MHz. Sweep = as necessary to capture the entire dwell time per hopping channel. Set the EUT for DH5, DH3 and DH1 packet transmitting.
4. Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g.. data rate. modulation format. etc.). repeat this test for each variation. The limit is specified in one of the subparagraphs of this Section. Submit this plot(s).

13.2 Test Result

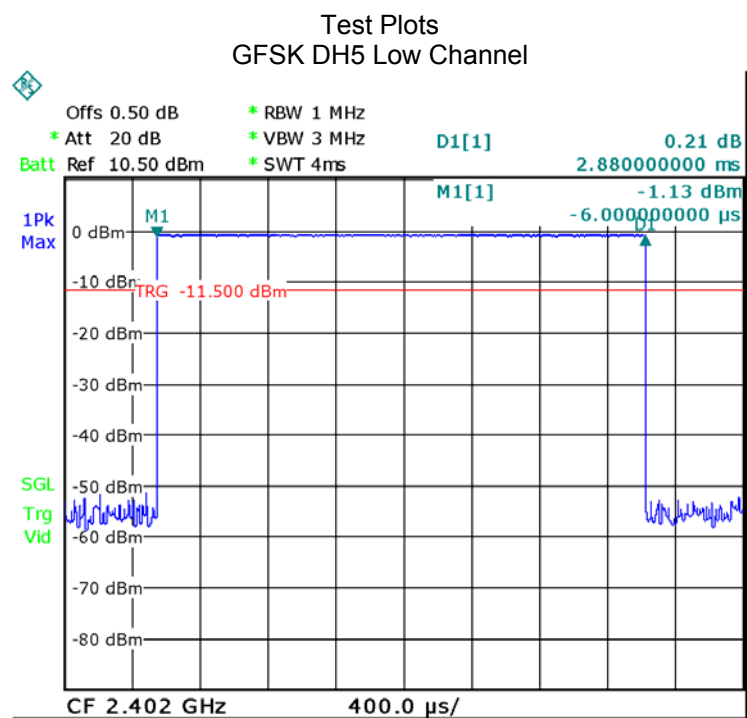
DH5 Packet permit maximum $1600 / 79 / 6$ hops per second in each channel (5 time slots RX, 1 time slot TX).

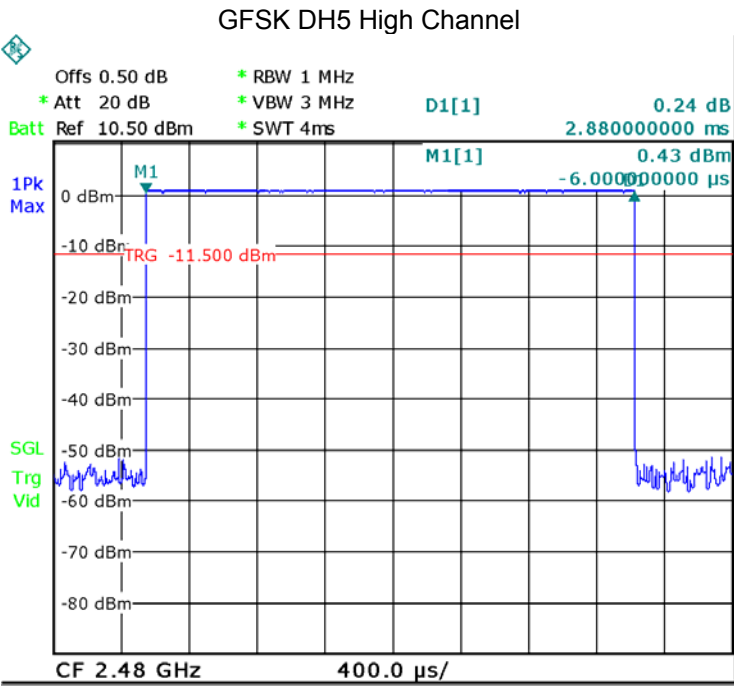
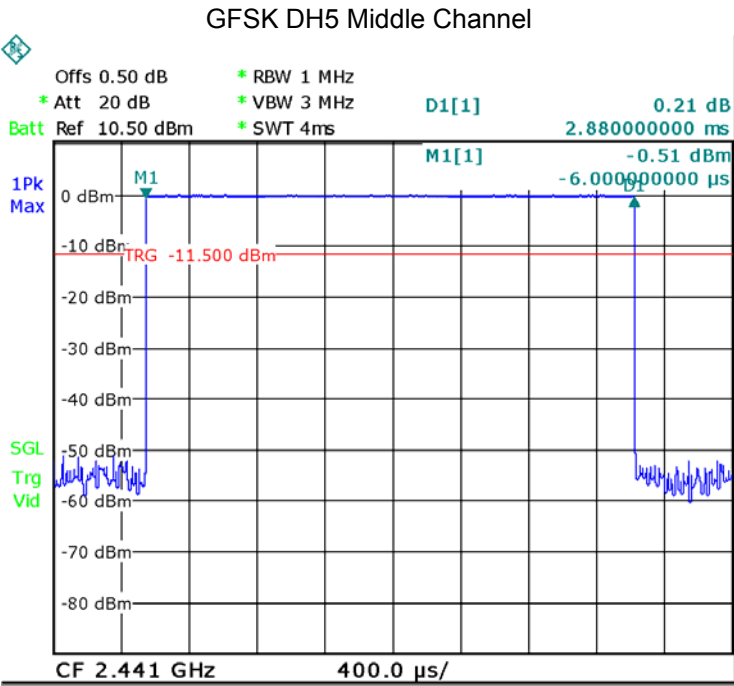
DH3 Packet permit maximum $1600 / 79 / 4$ hops per second in each channel (3 time slots RX, 1 time slot TX).

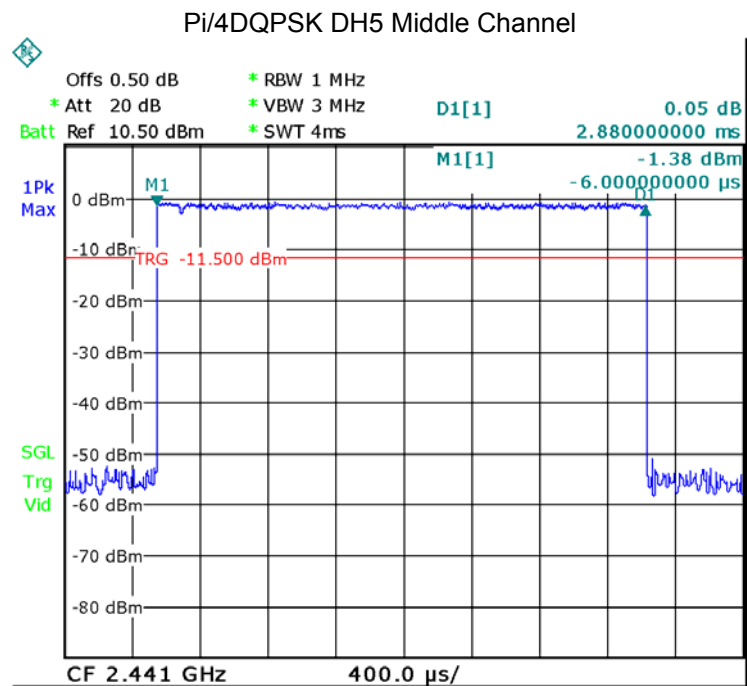
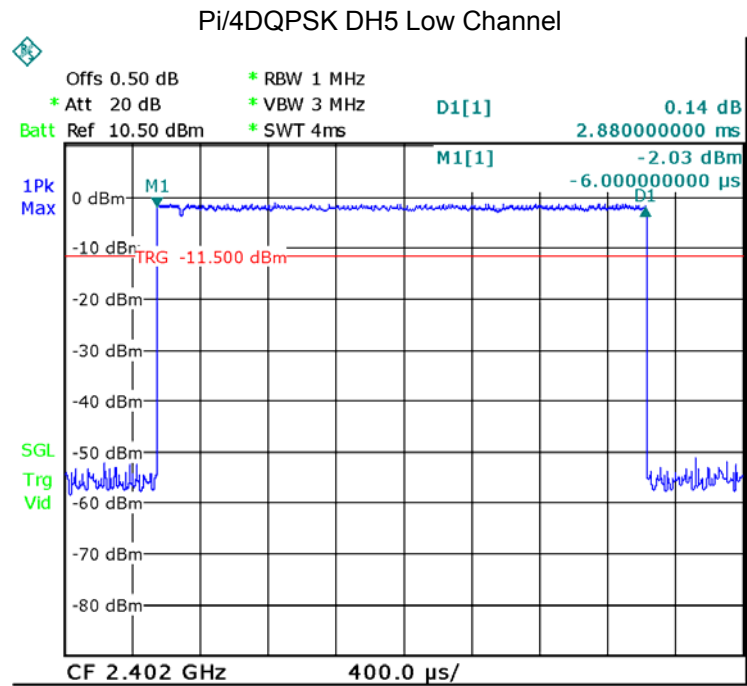
DH1 Packet permit maximum $1600 / 79 / 2$ hops per second in each channel (1 time slot RX, 1 time slot TX). So, the Dwell Time can be calculated as follows:

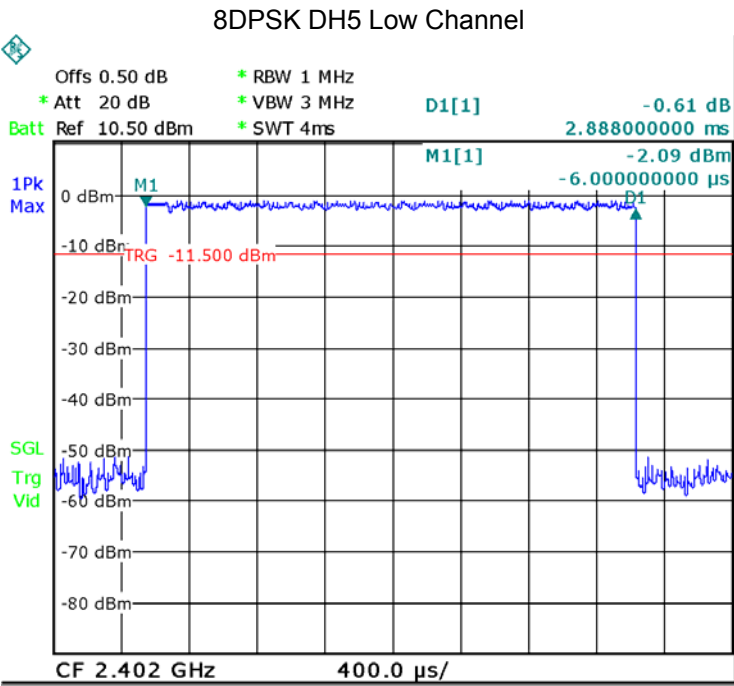
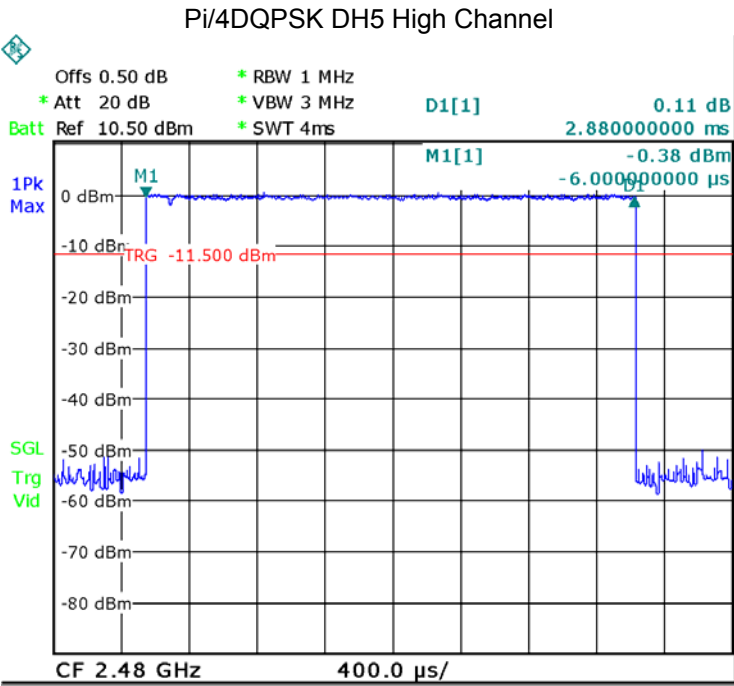
Data Packet	Dwell Time(s)
DH5	$1600/79/6*0.4*79*(MkrDelta)/1000$
DH3	$1600/79/4*0.4*79*(MkrDelta)/1000$
DH1	$1600/79/2*0.4*79*(MkrDelta)/1000$
Remark: Mkr Delta is once pulse time. Only the worst data(DH5) were show as follow.	

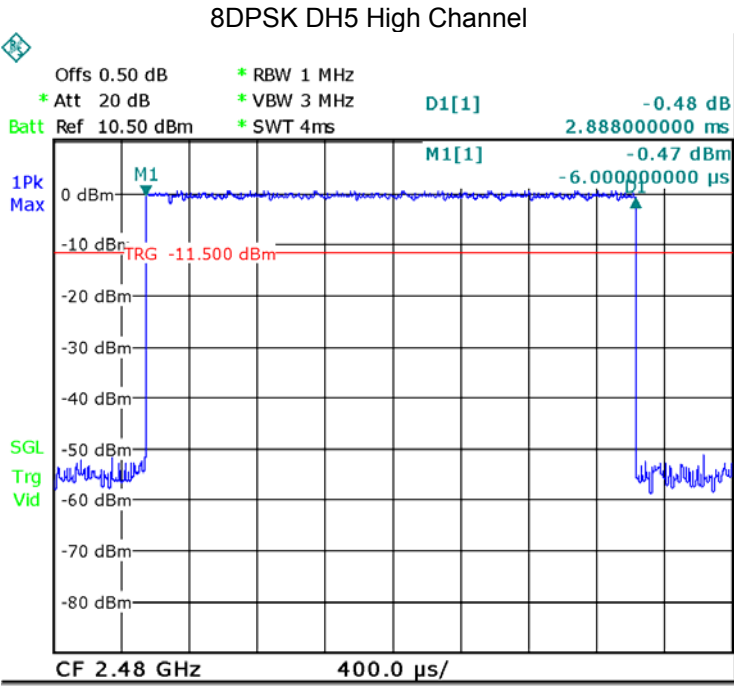
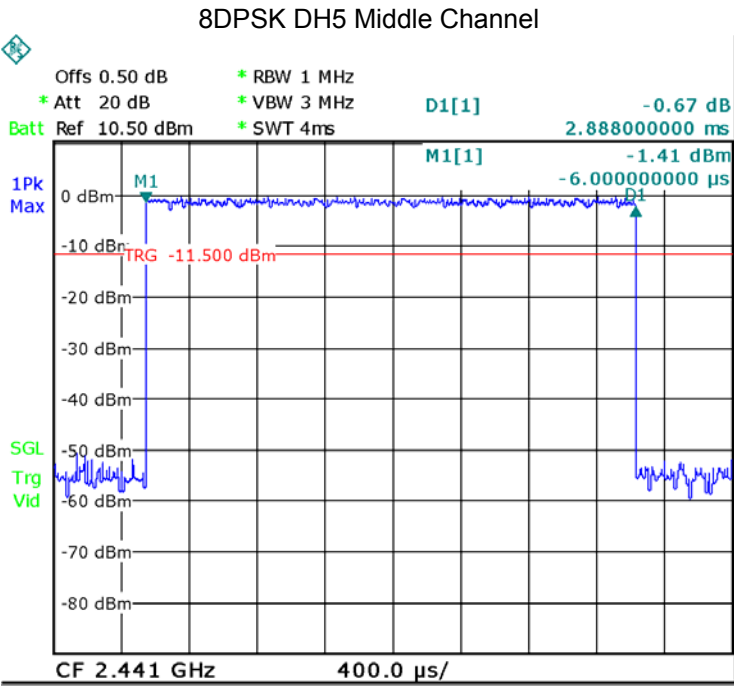
Modulation	Data Packet	Channel	pulse time(ms)	Dwell Time(ms)	Limits(s)
GFSK	DH5	Low	2.880	307.200	0.4
		middle	2.880	307.200	0.4
		High	2.880	307.200	0.4
Pi/4DQPSK	DH5	Low	2.880	307.200	0.4
		middle	2.880	307.200	0.4
		High	2.880	307.200	0.4
8DPSK	DH5	Low	2.888	308.053	0.4
		middle	2.888	308.053	0.4
		High	2.888	308.053	0.4











14 Antenna Requirement

According to the FCC Part 15 Paragraph 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. This product has a PCB printed antenna, fulfil the requirement of this section.

15 RF Exposure

Test Requirement: FCC Part 1.1307

Evaluation Method 447498 D01 General RF Exposure Guidance v05r02

15.1 Requirements

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances 50 mm are determined by:

$$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [f(\text{GHz})]^{3.0} \text{ for 1-g SAR and } 7.5 \text{ for 10-g extremity SAR where}$$

1. $f(\text{GHz})$ is the RF channel transmit frequency in GHz
2. Power and distance are rounded to the nearest mW and mm before calculation
3. The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

15.2 The procedures / limit

Conducted Peak power(dBm)	Conducted Peak power(mW)	Source-based time-averaged maximum conducted output power(mW)	Minimum test separation distance required for the exposure conditions (mm)	SAR Test Exclusion Thresholds(mW)
0.86	1.22	1.22	5	10

Remark: Max. duty factor is 100%

Calculation formula: Source-based time-averaged maximum conducted output power(mW)
=Conducted peak power(mW)*Duty factor

16 Photographs – Model HX-P750 Test Setup

16.1 Photograph – Conducted Emission Test Setup at Test Site2#



16.2 Photograph – Radiation Spurious Emission Test Setup

Below 30MHz at Test Site 2#



30MHz-1GHz at Test Site 2#



Above 1GHz at Test Site 1#

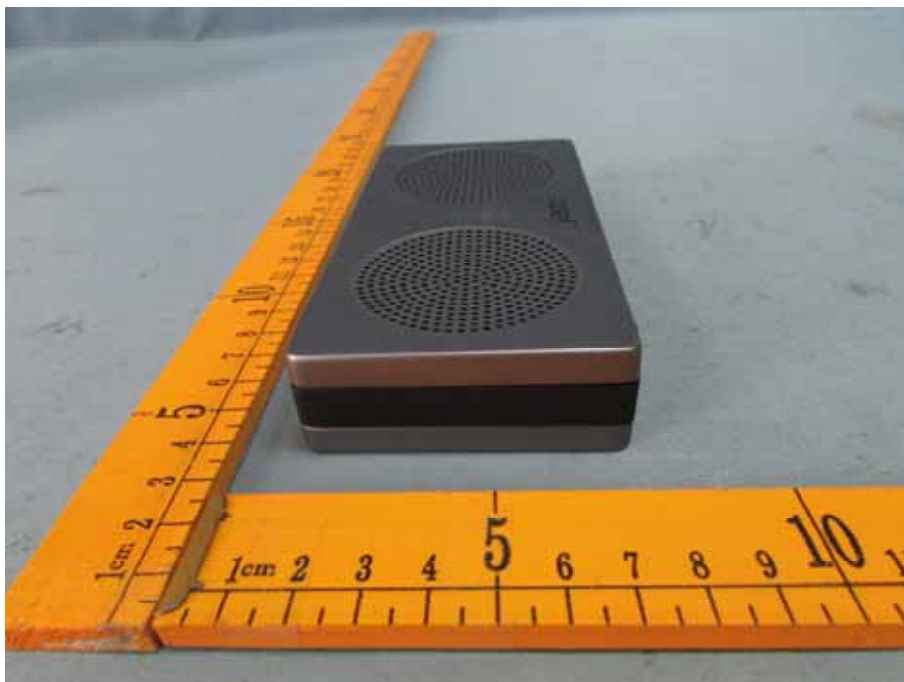


17 Photographs - Constructional Details

17.1 Model HX-P750 External View

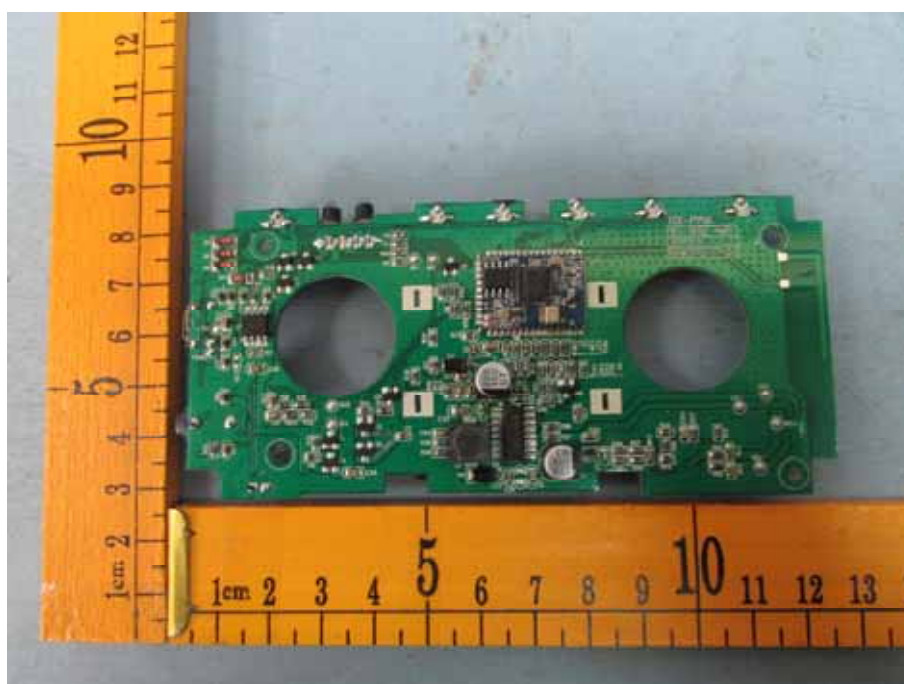
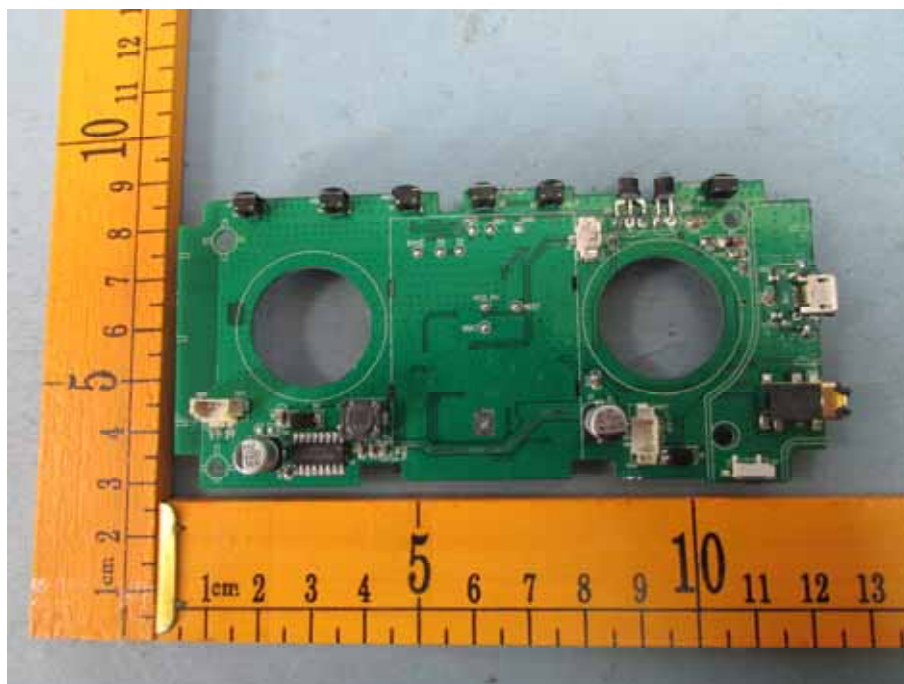


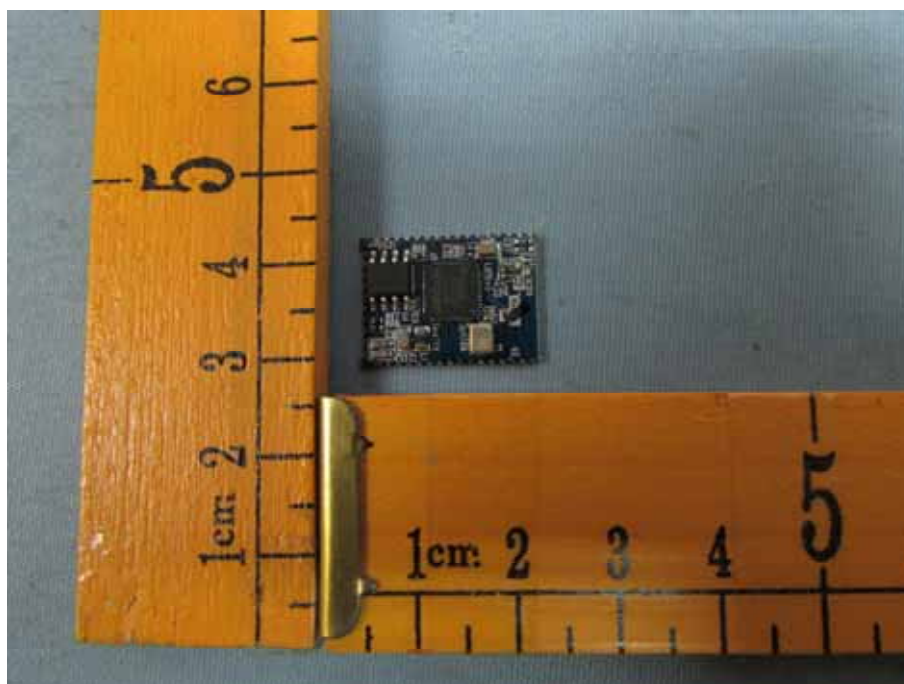


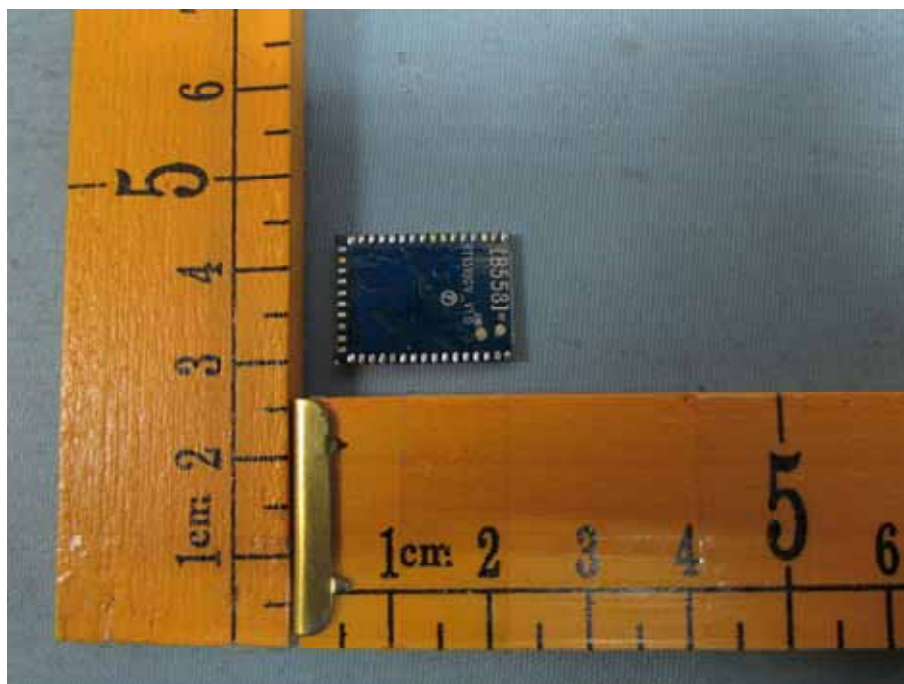


17.2 Model HX-P750 Internal View











===== End of Report =====